

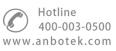
Page 1 of 90

FCC SAR Test Report

| Report No. | : | 1812C40179712505 |
|--------------|---|---|
| Applicant | : | Shenzhen Feima Robotics Co., Ltd. |
| Address | : | 13th Floor, Building A4, Nanshan Zhiyuan, No. 1001 Xueyuan Avenue, Taoyuan Street, Nanshan District, Shenzhen |
| Product Name | : | HANDHELD LASER SCANNER |
| Report Date | : | Feb.24, 2025 |

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited







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TEST REPORT

| Applicant | : | Shenzhen Feima Robotics Co., Ltd. |
|--------------|---|---|
| Manufacturer | : | Shenzhen Feima Robotics Co., Ltd. |
| Product Name | : | HANDHELD LASER SCANNER |
| Model No. | : | SLAM200, X200 ^{GO} |
| Trade Mark | : | N/A |
| Rating(s) | : | Input: 5V=3A/ 9V=3A/ 12V=3A/ 15V=3A/ 20V=3.25A Battery capacity: DC 10.8V, 3200mAh |

Test Standard(s) IEC/IEEE 62209-1528:2020; FCC 47 CFR Part 2.1093; 2

ANSI/IEEE C95.1:2019; Reference FCC KDB 447498 D01 v06; KDB 248227 D01 v02r02;

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEC/IEEE 62209-1528:2020, FCC 47 CFR Part 2.1093, IEEE Std C95.1-2019 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt

Date of Test

Dec. 20, 2024

Dec. 20, 2024 to Feb.24, 2025

Prepared By

Test Engineer

Biang fei Yang

(Qiangfei Yang)

Biangtei lang

(Qiangfei Yang)

(Kingkong Jin)

Approved & Authorized Signer

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Code:AB-RF-05-b



400-003-0500 www.anbotek.com



Version

| Version No. | Date | Description |
|-------------|--------------|---|
| R00 | Feb.06, 2025 | Original |
| R01 | Feb.17,2025 | The chapter of sample test photos within the report has been deleted. |
| R02 | Feb.24,2025 | After changing the power in the 802.11a mode for WIFI 5.2G ANT2, reselect the power corresponding to channel 5200 for the SAR test. |
| | | |

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1. Statement of Compliance

<Highest SAR Summary>

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC 47 CFR part 2.1093 and IEEE Std C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528:2020. The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

| Frequency Band | Highest Reported 1g-SAR(W/Kg) | Simultaneous SAR(W/Kg) | SAR Test Limit |
|----------------|----------------------------------|---------------------------|-------------------|
| | Body-worn (0mm) | UAN(W/Ng) | (W/Kg) |
| WLAN2.4G ANT1 | 0.548 | 1.130 | |
| WLAN2.4G ANT2 | 0.582 | 1.130 | |
| WLAN5.2G ANT1 | 0.579 | 1.184 | 1.6 |
| WLAN5.2G ANT2 | 0.605 | 1.104 | 1.0 |
| WLAN5.8G ANT1 | 0.602 | 1.240 | |
| WLAN5.8G ANT2 | 0.638 | 1.240 | |
| Test Result | PASS | | |

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC 47 CFR part 2.1093 and IEEE Std C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528:2020.

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2. General Information

2.1. Client Information

| Applicant | : | Shenzhen Feima Robotics Co., Ltd. | |
|--------------|---|---|--|
| Address | : | 13th Floor, Building A4, Nanshan Zhiyuan, No. 1001 Xueyuan Avenue, Taoyuan Street, Nanshan District, Shenzhen, China | |
| Manufacturer | : | Shenzhen Feima Robotics Co., Ltd. | |
| Address | : | 13th Floor, Building A4, Nanshan Zhiyuan, No. 1001 Xueyuan Avenue, Taoyuan Street, Nanshan District, Shenzhen, China | |
| Factory | : | N/A | |
| Address | : | N/A | |

2.2. Description of Equipment Under Test (EUT)

| Product Name | : | HANDHELD LASER SCANNER |
|--------------------|---|--|
| | | SLAM200, X200 ^{GO} |
| Model No. | : | (Note: All samples are the same except the model number, so we prepare |
| | | "SLAM200" for test only.) |
| Trade Mark | : | N/A |
| Test Power Supply | : | 10.8 V, 3200mAh |
| Test Sample No. | : | (Engineering Sample) |
| | | 2.4G WIFI: 2412-2462MHz |
| Tx Frequency | : | 5.2G WIFI: 5180-5240MHz |
| | | 5.8G WIFI: 5745-5825MHz |
| | | 2.4G WIFI: CCK, DQPSK, DBPSK, BPSK, QPSK, 16QAM, 64QAM, |
| Type of Modulation | : | 256QAM,1024QAM |
| | | 5G WIFI: BPSK, QPSK, 16QAM, 64QAM, 256QAM,1024QAM |
| Category of device | : | Portable device |
| Remark: | | |

The above DUT's information was declared by manufacturer. Please refer to the specifications or user's manual for more detailed description.

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2.3. Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2.4. Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

- FCC 47 CFR Part 2.1093
- IEEE Std C95.1-2019
- IEC/IEEE 62209-1528:2020
- KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz v01r04
- KDB 865664 D02 RF Exposure Reporting v01r02
- KDB 447498 D01 General RF Exposure Guidance v06
- KDB 248227 D01 802 11 Wi-Fi SAR v02r02

2.5. Environment of Test Site

| Items | Required | Actual |
|-----------------|----------|--------|
| Temperature (℃) | 18-25 | 22~23 |
| Humidity (%RH) | 30-70 | 55~65 |

2.6. Test Configuration

For WIIF SAR testing, engineering testing software installed on the EUT can provide continuous transmitting RF signal.

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2.7. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.:434132

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 434132.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

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3. Specific Absorption Rate (SAR)

3.1. Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

3.2. SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ).The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

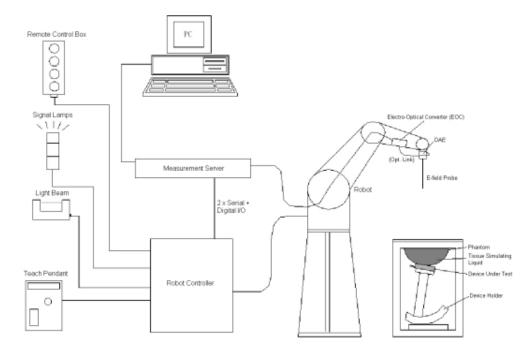
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4. SAR Measurement System



DASY System Configurations

The DASYsystem for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- > A data acquisition electronic (DAE) attached to the robot arm extension
- > A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- > A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- > A probe alignment unit which improves the accuracy of the probe positioning
- > A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- > The SAM twin phantom and ELI4 phantom
- > A device holder
- Tissue simulating liquid
- > Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

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Product Safet

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

E-Field Probe Specification

<EX3DV4 Probe>

| Construction | Symmetrical design with triangular | |
|---------------|--|---|
| | core | |
| | Built-in shielding against static charges | |
| | PEEK enclosure material (resistant to | |
| | organic solvents, e.g., DGBE) | 2.1 |
| Frequency | 10 MHz to 6 GHz; Linearity: ± 0.2 dB | |
| Directivity | ± 0.3 dB in HSL (rotation around probe | and the second se |
| | axis) | and the second se |
| | ± 0.5 dB in tissue material (rotation | Contractor of the local division of the |
| | normal to probe axis) | |
| Dynamic Range | 10 μ W/g to 100 W/kg; Linearity: ± 0.2 | |
| | dB (noise: typically< 1 μW/g) | Photo of EX3DV4 |
| Dimensions | Overall length: 330 mm (Tip: 20 mm) | |
| | Tip diameter: 2.5 mm (Body: 12 mm) | |
| | Typical distance from probe tip to | |
| | dipole centers: 1 mm | |

> E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4.2. Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.

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Photo of DAE

4.3. Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX60L) type from Stäubli SA (France). For the 6-axis controllersystem, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäublirobot series have many features that are important for our application:

- > High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- > Jerk-free straight movements
- > Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

4.4. Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chipdisk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.

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Photo of Server for DASY5

4.5. Phantom

<SAM Twin Phantom>

| Shell Thickness | 2 ± 0.2 mm; Center ear point: 6 ± 0.2 mm | |
|----------------------|--|----------------------|
| Filling Volume | Approx. 25 liters | THE TON |
| Dimensions | Length: 1000 mm; Width: 500 mm; Height: adjustable feet | |
| Measurement Areas | Left Hand, Right Hand, Flat Phantom | |
| | | Photo of SAM Phantom |

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

<ELI4 Phantom>

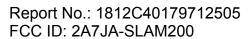
| Shell Thickness | 2 ± 0.2 mm (sagging: <1%) | |
|-----------------|----------------------------|-----------------------|
| Filling Volume | Approx. 30 liters | |
| Dimensions | Major ellipse axis: 600 mm | |
| | Minor axis:400 mm | |
| | | Photo of ELI4 Phantom |

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

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4.6. Device Holder

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ±0.5mm would produce a SAR uncertainty of ± 20%. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.



Device Holder

4.7. Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [W/kg]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose Shenzhen Anbotek Compliance Laboratory Limited Code:AB-RF-05-b





media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD X) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

| Probe parameters: | - Sensitivity | Norm _i , a _{i0} , a _{i1} , a _{i2} |
|-------------------|---------------------------|---|
| | - Conversion factor | ConvFi |
| | - Diode compression point | : dcp _i |
| Device parameters | : - Frequency | f |
| | - Crest factor | cf |
| Media parameters: | - Conductivity | σ |
| | - Density | ρ |

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power.

The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with V_i = compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes:
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

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H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with V_i = compensated signal of channel i, (i= x, y, z)
 Norm_i= sensor sensitivity of channel i, (i= x, y, z), μV/(V/m)² for E-field Probes
 ConvF= sensitivity enhancement in solution
 a_{ij}= sensor sensitivity factors for H-field probes
 f = carrier frequency [GHz]

 E_i = electric field strength of channel iin V/m

H_i= magnetic field strength of channel iin A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$\mathbf{E}_{tot} = \sqrt{\mathbf{E}_x^2 + \mathbf{E}_y^2 + \mathbf{E}_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in W/kg

E_{tot}= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

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5. Test Equipment List

| Monufacturer | Nome of Equipment | Ture/Medel | Serial | Calib | ration |
|---------------|-------------------------------|--------------------|----------------|---------------|---------------|
| Manufacturer | Name of Equipment | Type/Model | Number | Last Cal. | Due Date |
| SPEAG | 2450MHz System Validation Kit | D2450V2 | 910 | Jun. 11,2024 | Jun. 10,2027 |
| SPEAG | 5GHz System Validation Kit | D5GHzV2 | 1160 | Oct. 02, 2024 | Oct. 01, 2027 |
| SPEAG | Data Acquisition Electronics | DAE4 | 387 | Sept.02,2024 | Sept.01,2025 |
| SPEAG | Dosimetric E-Field Probe | EX3DV4 | 7396 | May 06,2024 | May 05,2025 |
| Agilent | ENA Series Network Analyzer | E5071C | MY46317418 | Oct.26, 2024 | Oct.25, 2025 |
| SPEAG | DAK | DAK-3.5 | 1226 | NCR | NCR |
| SPEAG | SAM Twin Phantom | QD000P40CD | 1802 | NCR | NCR |
| SPEAG | ELI Phantom | QDOVA004AA | 2058 | NCR | NCR |
| Mini-Circuits | Amplifier | ZVA-183W-S+ | 932502132 | NCR | NCR |
| Agilent | Power Meter | N1914A | MY50001102 | Oct.26, 2024 | Oct.25, 2025 |
| Agilent | Power Sensor | E9323A | US40410647 | Jan. 23, 2024 | Jan. 22, 2025 |
| Agilent | Power Sensor | E9323A | MY53100007 | Jan. 23, 2024 | Jan. 22, 2025 |
| CDKMV | Attenuator | 6610 | 6610-1 | Oct.20, 2024 | Oct.19, 2025 |
| CDKMV | Attenuator | 6606 | 6606-1 | Oct.20, 2024 | Oct.19, 2025 |
| Agilent | Spectrum Analyzer | N9020A | MY51170037 | Oct.26, 2024 | Oct.25, 2025 |
| Agilent | Signal Generation | N5182A | MY48180656 | Oct.26, 2024 | Oct.25, 2025 |
| Worken | Directional Coupler | 0110A05601O -10 | COM5BNW1A 2 | Oct.26, 2024 | Oct.25, 2025 |

Note:

- 1. The calibration certificate of DASY can be referred to appendix C of this report.
- 2. The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
- 3. The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
- 4. The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
- 5. In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it.

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6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:

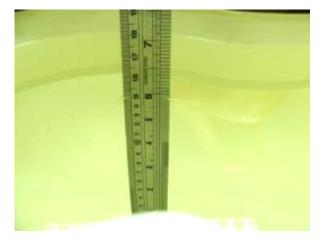


Photo of Liquid Height for Head SAR

The following table shows the measuring results for simulating liquid.

| Maggurad | Measured Target Tissue | | | Measure | | | | |
|--------------------|------------------------|------|-------|------------------------|------|---------------------|-----------------|-------------|
| Frequency (MHz) | ٤r | σ | ٤r | Delta (ध r) (%) | σ | Delta (σ) (%) | Liquid Temp. | Test Data |
| 2450 | 39.2 | 1.80 | 39.35 | 0.38 | 1.75 | -2.78 | 22.3 | Jan.12,2025 |
| 2462 | 39.22 | 1.83 | 39.43 | 0.54 | 1.78 | -2.73 | 22.3 | Jan.12,2025 |
| 5200 | 36.00 | 4.66 | 36.22 | 0.61 | 4.52 | -3.00 | 22.6 | Feb.24,2025 |
| 5240 | 35.96 | 4.70 | 35.58 | -1.06 | 4.68 | -0.43 | 22.8 | Jan.14,2025 |
| 5745 | 35.18 | 5.16 | 35.06 | -0.34 | 5.34 | 3.49 | 23.5 | Jan.14,2025 |
| 5800 | 35.30 | 5.27 | 35.15 | -0.42 | 5.36 | 1.71 | 23.5 | Jan.14,2025 |

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7. System Verification Procedures

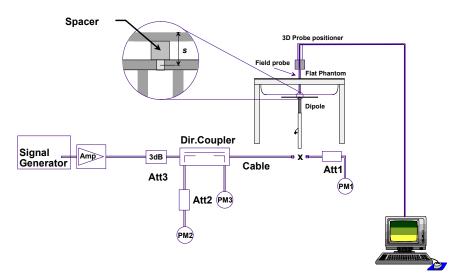
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

> Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

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Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

| Frequency (MHz) | Power fed onto reference dipole (mW) | Targeted SAR (W/kg) | Measured SAR (W/kg) | Normalized SAR (W/kg) | Deviation (%) | Date |
|--------------------|---|------------------------|---------------------------|-----------------------------|------------------|-------------|
| 2450 | 250 | 52.4 | 12.79 | 51.16 | -2.37 | Jan.12,2025 |
| 5200 | 100 | 80.7 | 7.86 | 78.6 | -2.60 | Feb.24,2025 |
| 5800 | 100 | 82 | 7.88 | 78.8 | -3.90 | Jan.14,2025 |

Target and Measurement SAR after Normalized

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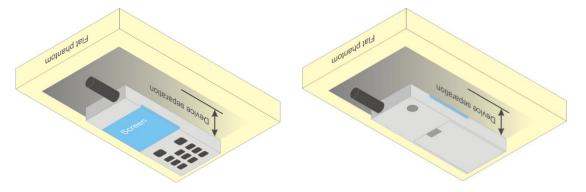


8. EUT Testing Position

8.1. Body Position

Body-worn operating configurations are tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in a normal use configuration. Per KDB 648474 D04, body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in FCC KDB 447498 D01 v06, 2015 should be used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode, when applicable. When the reported SAR for body-worn accessory, measured without a headset connected to the handset is < 1.2 W/kg, the highest reported SAR configuration for that wireless mode and frequency band should be repeated for that body-worn accessory with a handset attached to the handset.

Accessories for body-worn operation configurations are divided into two categories: those that do not contain metallic components and those that do contain metallic components and those that do contain metallic components. When multiple accessories that do not contain metallic components are supplied with the device, the device is tested with only the accessory that dictates the closest spacing to the body. Then multiple accessories that contain metallic components are test with the device with each accessory. If multiple accessories share an identical metallic component (i.e. the same metallic belt-chip used with different holsters with no other metallic components) only the accessory that dictates the closest spacing to the body is tested.



Body Worn Position

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9. Measurement Procedures

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels attheworst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1. Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from sensor to surface
- (f) Calculation of the averaged SAR within masses of 1g and 10g

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9.2. Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3. Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

| Area scan | narametere | extracted from | FCC KDB | 865664 001 | SAD | magguramant | 100 MHz to 6 GHz. |
|------------|------------|----------------|---------|------------|-----|-------------|-------------------|
| Alea Scall | parameters | exilacted iton | | 000004 D01 | SAR | measurement | |

| | \leq 3 GHz | > 3 GHz | |
|---|--|--|--|
| Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface | $5 \pm 1 \text{ mm}$ | $\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$ | |
| Maximum probe angle from probe axis to phantom surface normal at the measurement location | $30^{\circ}\pm1^{\circ}$ | $20^{\circ}\pm1^{\circ}$ | |
| | \leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm | $3 - 4 \text{ GHz}: \le 12 \text{ mm}$ $4 - 6 \text{ GHz}: \le 10 \text{ mm}$ | |
| Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area} | When the x or y dimension of the test device, in the measurement plane orientation, is smaller than the above, the measurement resolution must be \leq the corresponding x or y dimension of the test device with at least one measurement point on the test device. | | |

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9.4. Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label.

Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

| | | | \leq 3 GHz | > 3 GHz |
|--|---|--|--|--|
| Maximum zoom scan s | patial reso | lution: Δx_{Zoom} , Δy_{Zoom} | ≤ 2 GHz: ≤ 8 mm 2 - 3 GHz: ≤ 5 mm [*] | $3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$ |
| | uniform grid: $\Delta z_{Zoom}(n)$ | | $\leq 5 \text{ mm}$ | 3 – 4 GHz: ≤ 4 mm 4 – 5 GHz: ≤ 3 mm 5 – 6 GHz: ≤ 2 mm |
| Maximum zoom scan spatial resolution, normal to phantom surface | graded | $\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface | \leq 4 mm | 3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm |
| ~ | grid ∆z _{Zoom} (n>1): between subsequent points | | ≤1.5·∆z | _{Zoom} (n-1) |
| Minimum zoom scan volume | x, y, z | | ≥ 30 mm | 3 – 4 GHz: ≥ 28 mm 4 – 5 GHz: ≥ 25 mm 5 – 6 GHz: ≥ 22 mm |

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

* When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

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9.5. Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregateSAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6. Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

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10. Conducted Power

WIFI 2.4G

ANT1

| Mode | Channel | Frequency (MHz) | Conducted Power(dBm) | Tune-up power(dBm) |
|-----------|---------|--------------------|-------------------------|-----------------------|
| | 1 | 2412 | 12.88 | 13.00 |
| 802.11b | 6 | 2437 | 13.00 | 13.50 |
| | 11 | 2462 | 13.46 | 13.50 |
| | 1 | 2412 | 14.26 | 14.50 |
| 802.11g | 6 | 2437 | 14.44 | 14.50 |
| | 11 | 2462 | 14.71 | 15.00 |
| 802.11n20 | 1 | 2412 | 13.65 | 14.00 |
| | 6 | 2437 | 13.80 | 14.00 |
| | 11 | 2462 | 14.32 | 14.50 |

ANT2

| Mode | Channel | Frequency (MHz) | Conducted Power(dBm) | Tune-up power(dBm) |
|-----------|---------|--------------------|-------------------------|-----------------------|
| | 1 | 2412 | 14.62 | 15.00 |
| 802.11b | 6 | 2437 | 14.83 | 15.00 |
| | 11 | 2462 | 15.37 | 15.50 |
| | 1 | 2412 | 15.50 | 16.00 |
| 802.11g | 6 | 2437 | 15.73 | 16.00 |
| | 11 | 2462 | 16.06 | 16.50 |
| | 1 | 2412 | 13.63 | 14.00 |
| 802.11n20 | 6 | 2437 | 13.96 | 14.00 |
| | 11 | 2462 | 14.13 | 14.50 |

MIMO

| Mode | Channel | Frequency (MHz) | Conducted Power(dBm) | Tune-up power(dBm) |
|-----------|---------|--------------------|-------------------------|-----------------------|
| | 1 | 2412 | 16.65 | 17.00 |
| 802.11n20 | 6 | 2437 | 16.89 | 17.00 |
| | 11 | 2462 | 17.24 | 17.50 |

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WIFI5.2G

ANT 1

| Mode | Channel Frequency | Average Power output | Tune-up |
|----------------|-------------------|----------------------|------------|
| Mode | (MHz) | (dBm) | power(dBm) |
| | 5180 | 13.80 | 14.00 |
| 802.11a | 5200 | 13.80 | 14.00 |
| | 5240 | 14.84 | 15.00 |
| | 5180 | 12.99 | 13.00 |
| 802.11n 20 | 5200 | 11.32 | 11.50 |
| 20 | 5240 | 11.91 | 12.00 |
| 802.11n | 5190 | 10.73 | 11.00 |
| 40 | 5230 | 11.63 | 12.00 |
| | 5180 | 11.27 | 11.50 |
| 802.11ac 20 | 5200 | 11.23 | 11.50 |
| 20 | 5240 | 13.48 | 13.50 |
| 802.11ac | 5190 | 11.07 | 11.50 |
| 40 | 5230 | 11.56 | 12.00 |
| 802.11ac 80 | 5210 | 10.61 | 11.00 |

ANT 2

| Mode | Channel Frequency | Average Power output | Tune-up |
|----------------|-------------------|----------------------|------------|
| wode | (MHz) | (dBm) | power(dBm) |
| | 5180 | 13.32 | 13.50 |
| 802.11a | 5200 | 13.52 | 14.00 |
| | 5240 | 11.52 | 12.00 |
| | 5180 | 11.48 | 11.50 |
| 802.11n 20 | 5200 | 11.53 | 12.00 |
| 20 | 5240 | 12.48 | 12.50 |
| 802.11n | 5190 | 11.02 | 11.50 |
| 40 | 5230 | 11.62 | 12.00 |
| | 5180 | 11.64 | 12.00 |
| 802.11ac 20 | 5200 | 11.60 | 12.00 |
| 20 | 5240 | 12.65 | 13.00 |
| 802.11ac | 5190 | 11.68 | 12.00 |
| 40 | 5230 | 11.81 | 12.00 |
| 802.11ac 80 | 5210 | 11.02 | 11.50 |

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MIMO

| Mode | Channel Frequency | Average Power output | Tune-up |
|----------------|-------------------|----------------------|------------|
| woue | (MHz) | (dBm) | power(dBm) |
| | 5180 | 15.31 | 15.50 |
| 802.11n 20 | 5200 | 14.44 | 14.50 |
| | 5240 | 15.21 | 15.50 |
| 802.11n | 5190 | 13.89 | 14.00 |
| 40 | 5230 | 14.64 | 15.00 |
| | 5180 | 14.47 | 14.50 |
| 802.11ac 20 | 5200 | 14.43 | 14.50 |
| 20 | 5240 | 16.10 | 16.50 |
| 802.11ac | 5190 | 14.40 | 14.50 |
| 40 | 5230 | 14.70 | 15.00 |
| 802.11ac 80 | 5210 | 13.83 | 14.00 |

WIFI 5.8G

ANT 1

| Mode | Channel Frequency | Average Power output | Tune-up |
|----------------|-------------------|----------------------|------------|
| | (MHz) | (dBm) | power(dBm) |
| | 5745 | 13.87 | 14.00 |
| 802.11a | 5785 | 13.11 | 13.50 |
| | 5825 | 11.94 | 12.00 |
| | 5745 | 13.15 | 13.50 |
| 802.11n 20 | 5785 | 11.93 | 12.00 |
| 20 | 5825 | 11.16 | 11.50 |
| 802.11n | 5755 | 12.74 | 13.00 |
| 40 | 5795 | 11.81 | 12.00 |
| | 5745 | 13.02 | 13.50 |
| 802.11ac 20 | 5785 | 13.85 | 14.00 |
| 20 | 5825 | 11.12 | 11.50 |
| 802.11ac | 5755 | 13.07 | 13.50 |
| 40 | 5795 | 12.15 | 12.50 |
| 802.11ac 80 | 5775 | 12.23 | 12.50 |

ANT 2

| Mode | Channel Frequency | Average Power output | Tune-up |
|---------|-------------------|----------------------|------------|
| Mode | (MHz) | (dBm) | power(dBm) |
| 802.11a | 5745 | 12.18 | 12.50 |

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| | 5785 | 11.32 | 11.50 |
|----------------|------|-------|-------|
| | 5825 | 11.32 | 11.50 |
| | 5745 | 11.59 | 12.00 |
| 802.11n 20 | 5785 | 10.59 | 11.00 |
| 20 | 5825 | 10.30 | 10.50 |
| 802.11n | 5755 | 11.01 | 11.50 |
| 40 | 5795 | 10.83 | 11.00 |
| | 5745 | 11.53 | 12.00 |
| 802.11ac 20 | 5785 | 10.66 | 11.00 |
| 20 | 5825 | 10.33 | 10.50 |
| 802.11ac | 5755 | 11.07 | 11.50 |
| 40 | 5795 | 10.67 | 11.00 |
| 802.11ac 80 | 5775 | 10.46 | 10.50 |

MIMO

| Mode | Channel Frequency | Average Power output | Tune-up |
|----------------|-------------------|---|--|
| Mode | (MHz) | (dBm) | power(dBm) |
| | 5745 | 15.45 | 15.50 |
| 802.11n 20 | 5785 | 14.32 | 14.50 |
| 20 | 5825 | 13.76 14.00 14.97 15.00 14.36 14.50 15.35 15.50 | 14.00 |
| 802.11n | 5755 | 14.97 | 15.00 |
| 40 | 5795 | 14.36 | 14.50 |
| | 5745 | 15.35 | 15.50 |
| 802.11ac 20 | 5785 | 15.55 | 16.00 |
| 20 | 5825 | 13.75 | power(dBm) 45 15.50 32 14.50 76 14.00 97 15.00 36 14.50 35 15.50 55 16.00 75 14.00 19 15.50 48 14.50 |
| 802.11ac | 5755 | 15.19 | 15.50 |
| 40 | 5795 | 13.76 14.00 14.97 15.00 14.36 14.50 15.35 15.50 15.55 16.00 13.75 14.00 15.19 15.50 14.48 14.50 | 14.50 |
| 802.11ac 80 | 5775 | 14.44 | 14.50 |

Note:

1. Per KDB 447498 D01, the 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

2. Base on the result of note1, RF exposure evaluation of 2.4G/5.2G/5.3G/5.4G/5.8G WIFI mode is required.

3. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion. Shenzhen Anbotek Compliance Laboratory Limited

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4. Per KDB 248227 D01, In the 2.4 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4 GHz OFDM conditions:

1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.

2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

<Bluetooth Conducted Power>

| Mode | Channel | Frequency (MHz) | Conducted Average Power (dBm) | Tune-up power(dBm) |
|----------------------|---------|--------------------|-------------------------------------|-----------------------|
| BT BDR | 00 | 2402 | 7.46 | 7.50 |
| (GFSK) | 39 | 2441 | 7.38 | 7.50 |
| (GFSK) | 78 | 2480 | 6.70 | 7.00 |
| | 00 | 2402 | 7.99 | 8.00 |
| BT EDR (Π/4DQPSK) | 39 | 2441 | 7.25 | 7.50 |
| (11/4DQF3K) | 78 | 2480 | 6.93 | 7.00 |
| BT EDR | 00 | 2402 | 7.87 | 8.00 |
| | 39 | 2441 | 8.06 | 8.50 |
| (8DPSK) | 78 | 2480 | 6.88 | 7.00 |
| | 00 | 2402 | 6.49 | 6.50 |
| BT BLE_1M | 19 | 2440 | 6.93 | 7.00 |
| (GFSK) | 39 | 2480 | 6.52 | 7.00 |
| | 01 | 2404 | 6.63 | 7.00 |
| BT BLE_2M | 19 | 2440 | 7.04 | 7.50 |
| (GFSK) | 38 | 2478 | 6.45 | 6.50 |

Note:

Per KDB 447498 D01v05r02, the 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f}(GHz)] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR

 $f(\mbox{GHz})$ is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

| Bluetooth Max. Power (dBm) | Separation Distance (mm) | Frequency (GHz) | exclusion thresholds |
|----------------------------|--------------------------|-----------------|----------------------|
| 8.50 | 5 | 2.441 | 2.65 |

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Per KDB 447498 D01, when the minimum test separation distance is <10 mm, a distance of 10 mm is applied to determine SAR test exclusion. The test exclusion threshold is 2.65which is<= 3, SAR testing is not required.

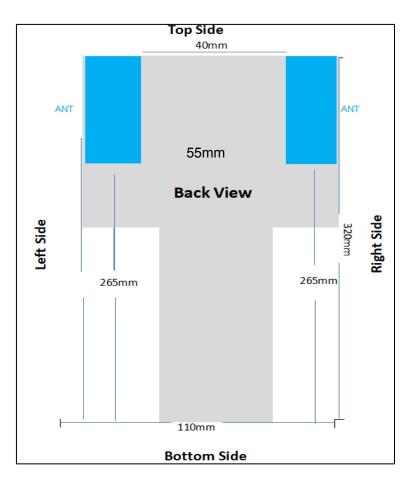
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11. Antenna Location



| | Distance of The Antenna to the EUT surface and edge | | | | | | | | | | | |
|----------|---|-------|-------------|-------------|-----------|------------|--|--|--|--|--|--|
| Antennas | Front | Back | Top Side | Bottom Side | Left Side | Right Side | | | | | | |
| BT/WIFI | BT/WIFI >25mm | | <25mm <25mm | | <25mm | <25mm | | | | | | |
| WIFI | >25mm | <25mm | <25mm | >25mm | <25mm | <25mm | | | | | | |

| | Positions for SAR tests; Body mode | | | | | | | | | | |
|----------------|------------------------------------|------|----------|-------------|-----------|------------|--|--|--|--|--|
| Antennas | Front | Back | Top Side | Bottom Side | Left Side | Right Side | | | | | |
| WIFI/BT ANT | No | Yes | Yes | No | Yes | Yes | | | | | |

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12. SAR Test Results Summary

General Note:

1.Per KDB 447498 D01v06, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.

Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor

2. Per KDB 447498 D01v06, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary

12.1. Body-worn SAR Results

2.4GWIFI

ANT1

| Plot No. | Band | Mode | Test Position | Gap (mm) | Ch. | Freq. (MHz) | Power | Tune-U p Limit (dBm) | Scaling Factor | Power Drift (dB) | Measured SAR _{1g} (W/kg) | Reported SAR _{1g} (W/kg) |
|-------------|------------|---------|------------------|-------------|-----|----------------|-------|-------------------------------|-------------------|------------------------|---|---|
| | WIFI2.4GHz | 802.11b | Left | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | 0.02 | 0.437 | 0.467 |
| | WIFI2.4GHz | 802.11b | Right | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | -0.01 | 0.425 | 0.454 |
| | WIFI2.4GHz | 802.11b | Тор | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | 0.03 | 0.267 | 0.285 |
| | WIFI2.4GHz | 802.11b | Bottom | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | N/A | N/A | N/A |
| | WIFI2.4GHz | 802.11b | Front | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | N/A | N/A | N/A |
| #1 | WIFI2.4GHz | 802.11b | Back | 0 | 11 | 2462 | 14.71 | 15.00 | 1.069 | 0.05 | 0.513 | 0.548 |

ANT2

| Plot No. | Band | Mode | Test Position | Gap (mm) | Ch. | Freq. (MHz) | Power | Tune-U p Limit (dBm) | Scaling Factor | Power Drift (dB) | Measured SAR _{1g} (W/kg) | Reported SAR _{1g} (W/kg) |
|-------------|------------|---------|------------------|-------------|-----|----------------|-------|-------------------------------|-------------------|------------------------|---|---|
| | WIFI2.4GHz | 802.11b | Left | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | 0.08 | 0.446 | 0.494 |
| | WIFI2.4GHz | 802.11b | Right | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | -0.02 | 0.468 | 0.518 |
| | WIFI2.4GHz | 802.11b | Тор | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | 0.04 | 0.213 | 0.236 |
| | WIFI2.4GHz | 802.11b | Bottom | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | N/A | N/A | N/A |
| | WIFI2.4GHz | 802.11b | Front | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | N/A | N/A | N/A |
| #2 | WIFI2.4GHz | 802.11b | Back | 0 | 11 | 2462 | 16.06 | 16.50 | 1.107 | 0.06 | 0.526 | 0.582 |

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5.2GWIFI

ANT1

| | | | Freq. | | Averag | Tune-U | Scalin | Powe | Measure | Reporte | | |
|------|------------|---------|----------|-----------|--------|--------|--------|-------|---------|---------|-------------------|-------------------|
| Plot | Band | Mode | Test | Gap Ch. (| (MHz | е | р | g | r | d | d | |
| No. | Bana | meas | Position | (mm) | • | (| Power | Limit | Factor | Drift | SAR _{1g} | SAR _{1g} |
| | | | | | | , | (dBm) | (dBm) | i actor | (dB) | (W/kg) | (W/kg) |
| | WIFI5.2GHz | 802.11a | Left | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | 0.01 | 0.456 | 0.473 |
| | WIFI5.2GHz | 802.11a | Right | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | -0.06 | 0.473 | 0.491 |
| | WIFI5.2GHz | 802.11a | Тор | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | 0.04 | 0.302 | 0.313 |
| | WIFI5.2GHz | 802.11a | Bottom | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | N/A | N/A | N/A |
| | WIFI5.2GHz | 802.11a | Front | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | N/A | N/A | N/A |
| #3 | WIFI5.2GHz | 802.11a | Back | 0 | 48 | 5240 | 14.84 | 15.00 | 1.038 | 0.03 | 0.558 | 0.579 |

ANT2

| Plot No. | Band | Mode | Test Position | Gap (mm) | Ch. | Freq. (MHz) | e | Tune-U p Limit (dBm) | Scalin g Factor | r Drift | Measure d SAR _{1g} (W/kg) | Reporte d SAR _{1g} (W/kg) |
|-------------|------------|---------|------------------|-------------|-----|--------------------|-------|-------------------------------|-----------------------|------------|---|---|
| | WIFI5.2GHz | 802.11a | Left | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | 0.03 | 0.442 | 0.494 |
| | WIFI5.2GHz | 802.11a | Right | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | -0.02 | 0.465 | 0.519 |
| | WIFI5.2GHz | 802.11a | Тор | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | 0.01 | 0.294 | 0.328 |
| | WIFI5.2GHz | 802.11a | Bottom | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | N/A | N/A | N/A |
| | WIFI5.2GHz | 802.11a | Front | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | N/A | N/A | N/A |
| #4 | WIFI5.2GHz | 802.11a | Back | 0 | 40 | 5200 | 13.52 | 14.00 | 1.117 | 0.04 | 0.542 | 0.605 |

5.8GWIFI

ANT1

| Plot No. | Band | Mode | Test Position | Gap (mm) | Ch. | Freq. | e | Tune-U p Limit (dBm) | Scalin g Factor | r Drift | Measure d SAR _{1g} (W/kg) | Reporte d SAR _{1g} (W/kg) |
|--|------------|---------|------------------|-------------|-----|-------|-------|-------------------------------|-----------------------|------------|---|---|
| | WIFI5.8GHz | 802.11a | Left | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | 0.06 | 0.452 | 0.466 |
| | WIFI5.8GHz | 802.11a | Right | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | -0.02 | 0.467 | 0.481 |
| | WIFI5.8GHz | 802.11a | Тор | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | 0.01 | 0.261 | 0.269 |
| | WIFI5.8GHz | 802.11a | Bottom | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | N/A | N/A | N/A |
| | WIFI5.8GHz | 802.11a | Front | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | N/A | N/A | N/A |
| #5 | WIFI5.8GHz | 802.11a | Back | 0 | 149 | 5745 | 13.87 | 14.00 | 1.030 | 0.15 | 0.584 | 0.602 |
| Shenzhen Anbotek Compliance Laboratory Limited Code:AB-RF-05-b | | | | | | | | | | | | |

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| Plot No. | Band | Mode | Test Position | Gap (mm) | | Freq. (MHz) | e | Tune-U p Limit (dBm) | Scalin g Factor | r Drift | Measure d SAR _{1g} (W/kg) | Reporte d SAR _{1g} (W/kg) |
|-------------|------------|---------|------------------|-------------|-----|--------------------|-------|-------------------------------|-----------------------|------------|---|---|
| | WIFI5.8GHz | 802.11a | Left | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | 0.01 | 0.493 | 0.531 |
| | WIFI5.8GHz | 802.11a | Right | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | -0.04 | 0.486 | 0.523 |
| | WIFI5.8GHz | 802.11a | Тор | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | 0.08 | 0.226 | 0.243 |
| | WIFI5.8GHz | 802.11a | Bottom | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | N/A | N/A | N/A |
| | WIFI5.8GHz | 802.11a | Front | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | N/A | N/A | N/A |
| #6 | WIFI5.8GHz | 802.11a | Back | 0 | 149 | 5745 | 12.18 | 12.50 | 1.076 | 0.07 | 0.593 | 0.638 |

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Code:AB-RF-05-b



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13. Simultaneous Transmission Analysis

13.1. Simultaneous TX SAR Considerations

| No. | Applicable Simultaneous Transmission |
|-----|--------------------------------------|
| 1. | WIFI 2.4G ANT1+WIFI 2.4G ANT2 |
| 2. | WIFI 5.2G ANT1+WIFI 5.2G ANT2 |
| 3. | WIFI 5.8G ANT1+WIFI 5.8G ANT2 |

Note:

1. WIFI 2.4GHz, WIFI 5GHz and Bluetooth cannot transmit simultaneously.

13.2. Evaluation of Simultaneous SAR

<Body Exposure Conditions>

Simultaneous transmission SAR for WIFI 2.4G ANT1+WIFI 2.4G ANT2

| | WIFI 2.4G | WIFI 2.4G | MAX. Σ SAR _{1g} | SAD Limit |
|---------------|------------------------|------------------------|---------------------------------|-----------------------------------|
| Test Position | ANT1 SAR _{1g} | ANT2 SAR _{1g} | (W/Kg) | SAR _{1g} Limit (W/Kg) |
| | (W/Kg) | (W/Kg) | (w/rtg) | (W/Kg) |
| Left | 0.467 | 0.494 | 0.961 | 1.6 |
| Right | 0.454 | 0.518 | 0.972 | 1.6 |
| Тор | 0.285 | 0.236 | 0.521 | 1.6 |
| Bottom | N/A | N/A | N/A | 1.6 |
| Front | N/A | N/A | N/A | 1.6 |
| Back | 0.548 | 0.582 | 1.13 | 1.6 |

Simultaneous transmission SAR for WIFI 5.2G ANT1+WIFI 5.2G ANT2

| Test Position | WIFI 5.2G ANT1 SAR _{1g} (W/Kg) | WIFI 5.2G ANT2 SAR _{1g} (W/Kg) | MAX. ΣSAR _{1g} (W/Kg) | SAR _{1g} Limit (W/Kg) |
|---------------|---|---|-----------------------------------|-----------------------------------|
| Left | 0.473 | 0.494 | 0.967 | 1.6 |
| Right | 0.491 | 0.519 | 1.010 | 1.6 |
| Тор | 0.313 | 0.328 | 0.641 | 1.6 |
| Bottom | N/A | N/A | N/A | 1.6 |
| Front | N/A | N/A | N/A | 1.6 |
| Back | 0.579 | 0.605 | 1.184 | 1.6 |

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Simultaneous transmission SAR for WIFI 5.8G ANT1+WIFI 5.8G ANT2

| | WIFI 5.8G | WIFI 5.8G | MAX. ΣSAR _{1α} | SAR _{1g} Limit |
|---------------|------------------------|------------------------|-------------------------|-------------------------|
| Test Position | ANT1 SAR _{1g} | ANT2 SAR _{1g} | (W/Kg) | (W/Kg) |
| | (W/Kg) | (W/Kg) | (Wing) | (wing) |
| Left | 0.466 | 0.531 | 0.997 | 1.6 |
| Right | 0.481 | 0.523 | 1.004 | 1.6 |
| Тор | 0.269 | 0.243 | 0.512 | 1.6 |
| Bottom | N/A | N/A | N/A | 1.6 |
| Front | N/A | N/A | N/A | 1.6 |
| Back | 0.602 | 0.638 | 1.240 | 1.6 |

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14. Measurement Uncertainty

| NO | Source | Uncert. ai(%) | Prob. Dist. | Div. k | ci (1g) | ci (10g) | Stand.U ncert. ui (1g) | Stand.U ncert. ui (10g) | Veff |
|----|---|------------------|----------------|-----------|---------|-------------|------------------------------|-------------------------------|------|
| 1 | Repeat | 0. 4 | Ν | 1 | 1 | 1 | 0.4 | 0.4 | 9 |
| | | | Instru | ument | | | | | |
| 2 | Probe calibration | 7 | Ν | 2 | 1 | 1 | 3.5 | 3.5 | 8 |
| 3 | Axial isotropy | 4.7 | R | √3 | 0.7 | 0.7 | 1.9 | 1.9 | œ |
| 4 | Hemispherical isotropy | 9.4 | R | √3 | 0.7 | 0.7 | 3.9 | 3.9 | ∞ |
| 5 | Boundary effect | 1.0 | R | √3 | 1 | 1 | 0.6 | 0.6 | ∞ |
| 6 | Linearity | 4.7 | R | √3 | 1 | 1 | 2.7 | 2.7 | 8 |
| 7 | Detection limits | 1.0 | R | √3 | 1 | 1 | 0.6 | 0.6 | × |
| 8 | Readout electronics | 0.3 | Ν | 1 | 1 | 1 | 0.3 | 0.3 | 8 |
| 9 | Response time | 0.8 | R | √3 | 1 | 1 | 0.5 | 0.5 | × |
| 10 | Integration time | 2.6 | R | √3 | 1 | 1 | 1.5 | 1.5 | 8 |
| 11 | Ambient noise | 3.0 | R | √3 | 1 | 1 | 1.7 | 1.7 | × |
| 12 | Ambient reflections | 3.0 | R | √3 | 1 | 1 | 1.7 | 1.7 | ∞ |
| 13 | Probe positioner mech. restrictions | 0.4 | R | √3 | 1 | 1 | 0.2 | 0.2 | 8 |
| 14 | Probe positioning with respect to phantom shell | 2.9 | R | √3 | 1 | 1 | 1.7 | 1.7 | 8 |
| 15 | Max.SAR evaluation | 1.0 | R | √3 | 1 | 1 | 0.6 | 0.6 | 8 |

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| | | | Test samp | ole rel | ated | | | | |
|------|---------------------------------|-----|-----------|--------------|---------------------------------|---------------|-------|-------|-----|
| 16 | Device positioning | 3.8 | N | 1 | 1 | 1 | 3.8 | 3.8 | 99 |
| 17 | Device holder | 5.1 | N | 1 | 1 | 1 | 5.1 | 5.1 | 5 |
| 18 | Drift of output power | 5.0 | R | √3 | 1 | 1 | 2.9 | 2.9 | 8 |
| | - | I | Phantom a | and s | et-up | | | | |
| 19 | Phantom uncertainty | 4.0 | R | √3 | 1 | 1 | 2.3 | 2.3 | 8 |
| 20 | Liquid conductivity (target) | 5.0 | R | √3 | 0.64 | 0.43 | 1.8 | 1.2 | 8 |
| 21 | Liquid conductivity (meas) | 2.5 | N | 1 | 0.64 | 0.43 | 1.6 | 1.2 | 8 |
| 22 | Liquid Permittivity (target) | 5.0 | R | √3 | 0.6 | 0.49 | 1.7 | 1.5 | 8 |
| 23 | Liquid Permittivity (meas) | 2.5 | N | 1 | 0.6 | 0.49 | 1.5 | 1.2 | 8 |
| (| Combined standard | | RSS | U | $C_{C} = \sqrt{\sum_{i=1}^{n}}$ | $C_i^2 U_i^2$ | 11.4% | 11.3% | 236 |
| unce | Expanded ertainty(P=95%) | | L | כ <i>א</i> נ | / ,k= | 2 | 22.8% | 22.6% | |

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Appendix A. Plots of SAR System Check

2450MHz System Check

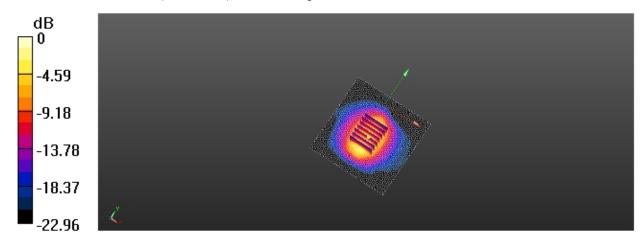
Date: Jan.12,2025

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:910 Communication System: CW; Frequency: 2450 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2450 MHz; σ = 1.75S/m; ϵ r = 39.35; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: May 06, 2024; Sensor-Surface: 1.4mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep.02.2024 Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 19.336 W/kg Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 84.267 V/m; Power Drift = 0.03dB Peak SAR (extrapolated) = 27.345 W/kg SAR(1 g) = 12.79W/kg; SAR(10 g) = 5.83W/kg Maximum value of SAR (measured) = 19.88W/kg



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5200MHz System Check

Date: Feb.24,2025

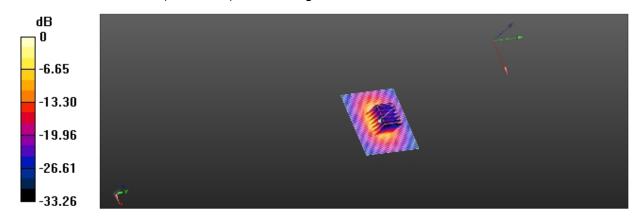
DUT: Dipole 5200 MHz; Type: D2450V2; Serial: D2450V2 - SN:910

Communication System: CW; Frequency: 5200 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5200 MHz; σ = 4.52S/m; ϵ r = 36.22; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(5.33, 5.33, 5.33); Calibrated: May 06, 2024; Sensor-Surface: 1.4mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep.02.2024 Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 24.5 W/kg Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 57.8344V/m; Power Drift = 0.06dB Peak SAR (extrapolated) = 34.38 W/kg SAR(1 g) =7.86W/kg; SAR(10 g) = 2.55 W/kg Maximum value of SAR (measured) = 15.4 W/kg



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5800MHz System Check

Date: Jan.14,2025

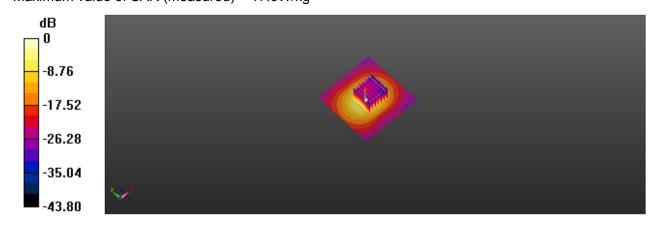
DUT: Dipole 5800MHz; Type: D2450V2; Serial: D2450V2 - SN:910

Communication System: CW; Frequency: 5800 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5800 MHz; σ = 5.36S/m; ϵ r = 35.15; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(4.92,4.92,4.92); Calibrated: May 06, 2024; Sensor-Surface: 1.4mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep.02.2024 Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=1.000 mm, dy=1.000mm Maximum value of SAR (interpolated) = 18.9W/kg Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 56.778 V/m; Power Drift = 0.06dB Peak SAR (extrapolated) = 32.6 W/kg SAR(1 g) = 7.88W/kg; SAR(10 g) = 2.36W/kg Maximum value of SAR (measured) = 17.6W/kg



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Appendix B. Plots of SAR Test Data

#1

Date: Jan.12,2025

WIFI 2.4G_802.11b_ Body Back _Ch11 ANT 1

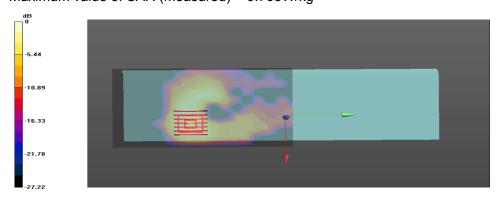
Communication System: UID 0, wifi (0); Frequency: 2462 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2462 MHz; σ = 1.77S/m; ϵ_r = 39.95; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: May 06, 2024; Sensor-Surface: 1.4mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 02, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.200mm, dy=1.200mm Maximum value of SAR (measured) = 1.358 W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 7.628 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 1.623 W/kg SAR(1 g) = 0.513 W/kg; SAR(10 g) = 0.226W/kg Maximum value of SAR (measured) = 0.768W/kg



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#2

Date: Jan.12,2025

WIFI 2.4G_802.11b_ Body Back _Ch11 ANT 2

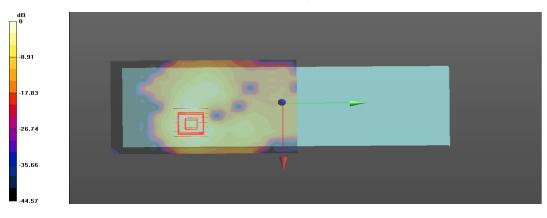
Communication System: UID 0, wifi (0); Frequency: 2462 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2462 MHz; σ = 1.77 S/m; ϵ_r = 39.95; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: May 06, 2024; Sensor-Surface: 1.4mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 02, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.200mm, dy=1.200mm Maximum value of SAR (measured) = 0.835 W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 8.226 V/m; Power Drift = 0.06 dB Peak SAR (extrapolated) = 0.863 W/kg SAR(1 g) = 0.526 W/kg; SAR(10 g) = 0.248 W/kg Maximum value of SAR (measured) = 0.763W/kg



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Date:Jan.13,2025

#3

WIFI 5.2G_802.11n20_ Body Back _Ch48 ANT 1

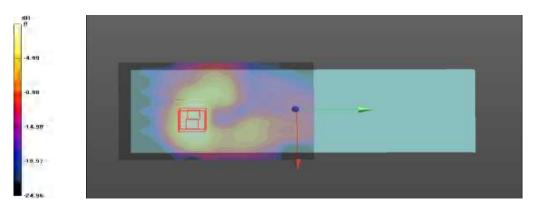
Communication System: UID 0, wifi (0); Frequency: 5240MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5240MHz; σ = 4.68 S/m; ϵ_r = 35.58; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(5.33, 5.33, 5.33); Calibrated: May 06, 2024; Sensor-Surface: 2mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 02, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.836 W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 7.745 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 0.782W/kg SAR(1 g) = 0.558 W/kg; SAR(10 g) = 0.229W/kg Maximum value of SAR (measured) = 0.637 W/kg



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Date:Feb.24,2025

#4

WIFI 5.2G_802.11n20_ Body Back _Ch40 ANT 2

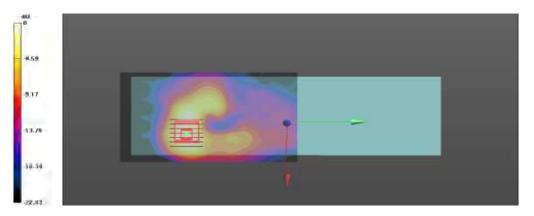
Communication System: UID 0, wifi (0); Frequency: 5200 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5200 MHz; σ = 4.52S/m; ϵ_r = 36.22; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(5.33, 5.33, 5.33); Calibrated: May 06, 2024; Sensor-Surface: 2mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 02, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.200mm, dy=1.200mm Maximum value of SAR (measured) = 0.863W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 6.265 V/m; Power Drift = 0.04 dB Peak SAR (extrapolated) = 0.833 W/kg SAR(1 g) = 0.542W/kg; SAR(10 g) = 0.305W/kg Maximum value of SAR (measured) = 0.768 W/kg



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Date:Jan.14,2025

#5

WIFI 5.8G_802.11a_ Body Back _Ch149

ANT 1

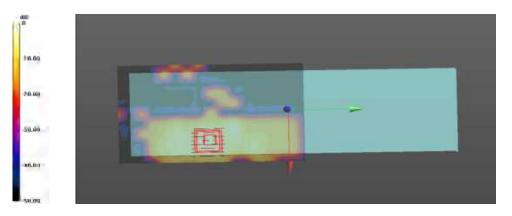
Communication System: UID 0, wifi (0); Frequency: 5745 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5745 MHz; σ = 5.34 S/m; ϵ_r = 35.06; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(4.92, 4.92, 4.92); Calibrated: May 06, 2024; Sensor-Surface: 2mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.755W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 7.321V/m; Power Drift = 0.15 dB Peak SAR (extrapolated) = 0.868 W/kg SAR(1 g) = 0.584 W/kg; SAR(10 g) = 0.232 W/kg Maximum value of SAR (measured) = 0.828W/kg



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Date:Jan.14,2025

#6

WIFI 5.8G_802.11a_ Body Back _Ch149

ANT 2

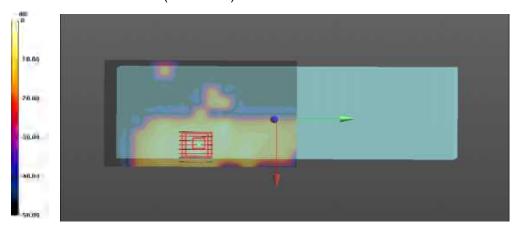
Communication System: UID 0, wifi (0); Frequency: 5745 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5745 MHz; σ = 5.34S/m; ϵ_r =35.06; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 – SN7396; ConvF(4.92, 4.92, 4.92); Calibrated: May 06, 2024; Sensor-Surface: 2mm (Mechanical Surface Detection) Electronics: DAE4 Sn387; Calibrated: Sep. 02, 2024; Phantom: ELI4; Type: QDOVA004AA; Serial:2058 Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Body Back /Area Scan (81x131x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.784 W/kg

Body Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 7.768V/m; Power Drift = 0.07 dB Peak SAR (extrapolated) = 0.826 W/kg SAR(1 g) = 0.593 W/kg; SAR(10 g) = 0.225 W/kg Maximum value of SAR (measured) = 0.834 W/k



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Appendix A. DASY System Calibration Certificate

Schmid & Pathar Engineering AG.

speag

Zeughausstresse 43, 8004 Zuich, Switzenand Phone +41 44 245 9700, Fax +41 44 245 9779 Info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points.

Battery Exchange. The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures Touch detection may be malfunctioning due to broken magnets in the E-stop Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR040315AD DAE4.doc

11.12.2009

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| Calibration Laboratory of |
|--|
| Schmid & Partner |
| Engineering AG |
| Zeughausstrasse 43, 8004 Zurich, Switzerland |



S Schweizerischer Kallbrierdienst Service sulsse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 0108

С

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Anbotek (Auden) Client

Certificate No: DAE4-387_Sep02

| Object | DAE4 - SD 000 D | 04 BM - SN: 387 | |
|---|--|--|---|
| Calibration procedure(s) | QA CAL-06.v29 Calibration procee | dure for the data acquisition elec | ctronics (DAE) |
| Calibration date: | September 02, 20 | 24 | |
| The measurements and the unce | ertainties with confidence pri icted in the closed laboratory | nai standards, which realize the physical un obability are given on the following pages ar (facility: environment temperature $(22 \pm 3)^{\circ}$ | nd are part of the certificate. |
| and a second second | 1 | | |
| | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
| | ID # SN: 0810278 | Cal Date (Certificate No.) 15-Aug-24 (No:22092) | Scheduled Calibration Aug-25 |
| Keithley Multimeter Type 2001 Secondary Standards | SN: 0810278 | 15-Aug-24 (No:22092) Check Date (in house) | Aug-25 Scheduled Check |
| Primary Standards Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit Calibrator Box V2 1 | SN: 0810278 | 15-Aug-24 (No:22092) | Aug-25 |
| Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit | SN: 0810278 | 15-Aug-24 (No:22092) Check Date (in house) 05-Jan-24 (in house check) | Aug-25 Scheduled Check In house check: Jan-25 |
| Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit Calibrator Box V2.1 | SN: 0810278 | 15-Aug-24 (No:22092) Check Date (in house) 05-Jan-24 (in house check) 05-Jan-24 (in house check) | Aug-25 Scheduled Check In house check: Jan-25 In house check: Jan-25 |
| Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit | SN: 0810278 | 15-Aug-24 (No:22092) Check Data (in house) 05-Jan-24 (in house check) 05-Jan-24 (in house check) Function | Aug-25 Scheduled Check In house check: Jan-25 In house check: Jan-25 |

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Calibration Laboratory of Schmid & Partner Engineering AG estrasse 43, 8004 Zurich, Switzerland Zeughau



Schweizerischer Kallbrierdienst Service suisse d'etalonnage Servizio ovizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

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Accredited by the Sweis Accreditation Service (SA5) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage.
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - ٠ Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery . alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-387_Sep02

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Code:AB-RF-05-b



400-003-0500 www.anbotek.com



DC Voltage Measurement

| High Range: | 1LSB = | 6.1µV, | full range = | -100+300 mV |
|-------------|--------|--------|--------------|-------------|
| Low Range: | 1LSB = | 61nV . | | -1+3mV |

| Calibration Factors | x | Y | z |
|---------------------|-----------------------|-----------------------|-----------------------|
| High Range | 404.489 ± 0.02% (k=2) | 404.852 ± 0.02% (k=2) | 404.862 ± 0.02% (k=2) |
| | | 3.95875 ± 1.50% (k=2) | |

Connector Angle

| Connector Angle to be used in DASY system | 53.0 ° ± 1 ° |
|---|--------------|
| | 53.0 ° ± 1 ° |

Certificate No: DAE4-387_Sep02

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

| High Range | Reading (µV) | Difference (µV) | Error (%) |
|-------------------|--------------|-----------------|-----------|
| Channel X + Input | 200032.85 | -3.31 | -0.00 |
| Channel X + Input | 20007.64 | 1,88 | 0.01 |
| Channel X - Input | +20003.48 | 1.18 | -0.01 |
| Channel Y + Input | 200034.23 | -1.43 | -0.00 |
| Channel Y + Input | 20006.60 | 0.91 | 0.00 |
| Channel Y - Input | -20004.04 | 0.72 | -0.00 |
| Channel Z + Input | 200035.38 | -0.83 | -0.00 |
| Channel Z + Input | 20003.69 | -2.11 | -0.01 |
| Channel Z - Input | -20006.38 | -1.59 | 0.01 |

| Low Range | Reading (µV) | Difference (µV) | Error (%) | |
|-------------------|--------------|-----------------|-----------|--|
| Channel X + Input | 2001.63 | 0.08 | 0.00 | |
| Channel X + Input | 202.29 | 0.70 | 0.35 | |
| Channel X - Input | -197.90 | 0.60 | -0.30 | |
| Channel Y + Input | 2001.33 | -0.07 | -0.00 | |
| Channel Y + Input | 200.86 | -0.60 | -0.30 | |
| Channel Y - Input | -199.87 | -1.23 | 0.62 | |
| Channel Z + Input | 2001.61 | 0.27 | 0.01 | |
| Channel Z + Input | 200,60 | -0.70 | -0.35 | |
| Channel Z - Input | -199.51 | -0.85 | 0.43 | |

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Common mode Input Voltage (mV) | High Range Average Reading (µV) | Low Range Average Reading (µV) |
|-----------|-----------------------------------|------------------------------------|-----------------------------------|
| Channel X | 200 | 13.50 | 11.56 |
| | - 200 | -8.64 | -11.18 |
| Channel Y | 200 | -0.81 | -1.28 |
| 1.2 | - 200 | 1.05 | 0.09 |
| Channel Z | 200 | 7.17 | 6.91 |
| | - 200 | -9.46 | -9.01 |

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Input Voltage (mV) | Channel X (µV) | Channel Y (µV) | Channel Z (µV) |
|-----------|--------------------|----------------|----------------|----------------|
| Channel X | 200 | | -1.70 | 0.33 |
| Channel Y | 200 | 10,70 | - | -0.38 |
| Channel Z | 200 | 7.11 | 7.89 | - |

Certificate No: DAE4-387_Sep02

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 15969 | 17466 |
| Channel Y | 15661 | 16162 |
| Channel Z | 15990 | 16190 |

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10M Ω

| | Average (μV) | min. Offset (µV) | max. Offset (µV) | Std. Deviation (µV) |
|-----------|--------------|------------------|------------------|------------------------|
| Channel X | 0.73 | -2.58 | 3.29 | 0.62 |
| Channel Y | 0.41 | -0.49 | 1.23 | 0.40 |
| Channel Z | -0.80 | -1.88 | 0.30 | 0.42 |

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

| | Zeroing (kOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 200 | 200 |
| Channel Y | 200 | 200 |
| Channel Z | 200 | 200 |

8. Low Battery Alarm Voltage (Typical values for information)

| Typical values | Alarm Level (VDC) | |
|----------------|-------------------|---|
| Supply (+ Vcc) | +7.9 | - |
| Supply (- Vcc) | -7.6 | |

9. Power Consumption (Typical values for information)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.01 | +6 | +14 |
| Supply (- Vcc) | -0.01 | -8 | -9 |

Certificate No: DAE4-387_Sep02

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Report No.: 1812C40179712505 FCC ID: 2A7JA-SLAM200

| Tel: +86-10-6230463 E-mail: cttlar cfonall) | | -10-62304633-2209 | |
|--|--|--|---|
| | otek (Auden) | | 98671 |
| CALIDIATION CE | RTIFICATE | | |
| Dbject | EX3DV4 | - SN:7396 | |
| alibration Procedure(s) | | | |
| | FF-Z12-0 | 06-08 on Procedures for Dosimetric E-field Probes | |
| | Calibratic | in Procedures for Dosimetric E-field Probes | |
| Calibration date: | May CG . : | 2024 | |
| All calibrations have been | simulation in the | | |
| | | e closed laboratory facility environment calibration) | temperature(22±3) [®] and |
| Calibration Equipment used | (M&TE critical for | | temperature(22±3) C and Scheduled Calibration |
| Calibration Equipment used | (M&TE critical for | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) | Scheduled Calibration Jun-24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 | (M&TE critical for ID # (101919 101547 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) | Scheduled Calibration Jun-24 Jun-24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 | (M&TE critical for ID # (101919 101547 101548 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Jun-24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24(CTTL, No.J24 X01547) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Jun-24 Mar-25 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator | (M&TE critical for ID # (101919 101547 101548 19N50W-10dB 18N50W-20dB | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24X01547) 13-Mar-24 (CTTL, No.J24X01548) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24(CTTL, No.J24 X01547) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24 X01547) 13-Mar-24 (CTTL, No.J24 X01548) 26-Sep-23 (SPEAG, No.EX3-7433_Sep22) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24X01547) 13-Mar-24 (CTTL, No.J24X01548) 26-Sep-23 (SPEAG, No.EX3-7433_Sep22) 13-Dec-23 (SPEAG, No.DAE4-549_Dec22) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24X01547) 13-Mar-24 (CTTL, No.J24X01548) 26-Sep-23 (SPEAG, No.EX3-7433_Sep22) 13-Dec-23 (SPEAG, No.DAE4-549_Dec22) Cal Date(Calibrated by, Certificate No.) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 Scheduled Calibration |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052505 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24(CTTL, No.J24X01547) 13-Mar-24(CTTL, No.J24X01548) 26-Sep-23(SPEAG, No.EX3-7433_Sep22) 13-Dec-23(SPEAG, No.DAE4-549_Dec22) Cal Date(Calibrated by, Certificate No.) 27-Jun-23 (CTTL, No.J23X04776) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 Scheduled Calibration Jun-24 Jan -25 Signature |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C | (M&TE critical for ID # (101919 101547 101548 19N50W-10dB 18N50W-20dB SN 7433 SN 7433 SN 549 ID # 6201052505 MY46110673 | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24 X01547) 13-Mar-24 (CTTL, No.J24 X01548) 26-Sep-23 (SPEAG, No DA24 X01548) 26-Sep-23 (SPEAG, No DA24 X01548) 26-Sep-23 (SPEAG, No DA24 X01548) 26-Sep-23 (SPEAG, No DA24 X01548) 27-Jun-23 (CTTL, No.J23 X04776) 13-Jan-24 (CTTL, No.J24 X00286) | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 Scheduled Calibration Jun-24 Jan -25 |
| Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator Reference20dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C Calibrated by: | (M&TE critical for ID # (101919 101547 101548 18N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052505 MY46110673 Name | calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24 X01547) 13-Mar-24 (CTTL, No.J24 X01548) 26-Sep-23 (SPEAG, No DAE4-549_Dec22) 13-Dec-23 (SPEAG, No DAE4-549_Dec22) Cal Date(Calibrated by, Certificate No.) 27-Jun-23 (CTTL, No.J23X04776) 13-Jan-24 (CTTL, No.J24X00286) Function | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 Scheduled Calibration Jun-24 Jan -25 Signature |
| Power sensor NRP-291 Power sensor NRP-291 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C | (M&TE critical for ID # (101919 101547 101548 19N50W-10dB 18N50W-20dB SN 7433 SN 549 ID # 6201052505 MY46110673 Name Yu Zongying | Calibration) Cal Date(Calibrated by, Certificate No.) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 20-Jun-23 (CTTL, No.J23 X07447) 13-Mar-24 (CTTL, No.J24 X01547) 13-Mar-24 (CTTL, No.J24 X01548) 26-Sep-23 (SPEAG, No.EX3-7433_Sep22) 13-Dec-23 (SPEAG, No.DAE4-549_Dec22) Cal Date(Calibrated by, Certificate No.) 27-Jun-23 (CTTL, No.J23X04776) 13-Jan-24 (CTTL, No.J24X00285) Function SAR Test Engineer | Scheduled Calibration Jun-24 Jun-24 Jun-24 Mar-25 Mar-25 Sep-24 Dec -24 Scheduled Calibration Jun-24 Jan -25 Signature |

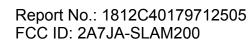
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Glossary:

Product Safety

| Giuasaiy. | |
|----------------|---|
| TSL | tissue simulating liquit |
| NORMX y.2 | sensitivity in free space |
| ConvF | sensitivity in TSL / NORMY, y.z. |
| DCP | diode compression point |
| CF | crest factor (1/duty_cycle) of the RF signal |
| A,B,C.D | modulation dependent linearization parameters |
| Polarization Φ | totation around probe axis |
| Polarization B | B rotation around an axis their is in the plane normal to probe axis (at measurement center), E |
| | 8=0 is normal to probe axis |
| | |

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013. "IEEE Recommended Practice for Determining the Poak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques : June 2013
- b) IEC 62209-1. "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the sar (frequency range of 300MHz to SGHz)". February 2005
 c) IEC 62209-2. "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication."
- c) IEC 62208-2. "Procedura to determine the Specific Absorption Mate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 565664 "SAR Measurement Requirements for 100 MHz to 6 GHz" Methods Applied and Interpretation of Parameters;

- NORMX, y.z. Assessed for E field balarization 8=0 (19900MHz in TEM cell (1>1800MHz; waveguide) NORMX, y.z are only intermediate values, i.e., the uncertainties of NORMX y.z does not effect the E²-field uncertainty inside TSL [see below ConvF].
- NORM(f x y z = NORMx y z* frequency_response (see Frequency Response Chert). This
 linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the
 frequency response is included in the stated uncertainty of ConvF.
- DCP* y.z. DCP are numerical linearization parameters assessed based on the data of power sweep (no unpartainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax, y, z; Bx, y, z: Cx, y, z: VRx y, z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not dopend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode
- ConvF and Boundary Effect Parameters. Assessed in flat phantom using E-field (or Temperature Transfer Standard for fs800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMX.y.2* ConvF whereby the uncertainty corresponds to that given for ConvF A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to ±100MHz.

 Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.

- Sensor Offset. The sensor offset corresponds to the offset of virtual measurement center from the probe by (on probe axis). No tolerance required.
- Connector Angle. The angle is assessed using the information gained by determining the NCRMs (no uncertainty required).

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Probe EX3DV4

SN: 7396

Calibrated: May 06, 2024

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: Z24-98671

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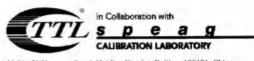
Code:AB-RF-05-b



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|----------------------|----------|----------|----------|-----------|
| Norm(µV/(V/m)2)A | 0.54 | 0.53 | 0.50 | ±10.0% |
| DCP(mV) ^B | 97.8 | 104.5 | 102.5 | |

Modulation Calibration Parameters

| UID | Communication System Name | | A dB | B dBõV | c | D dB | VR mV | Unc ^E (k=2) | |
|------|------------------------------|----|---------|-----------|-----|---------|----------|---------------------------|-------|
| 0 CW | 0 | CW | x | 0.0 | 0.0 | 1.0 | 0.00 | 199.9 | ±2.4% |
| | | Y | 0.0 | 0.0 | 1.0 | | 203.3 | | |
| | | Z | 0.0 | 0.0 | 1.0 | | 195.0 | | |

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6). ^B Numerical linearization parameter: uncertainty not required.

^E Uncertainly is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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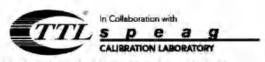
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Code:AB-RF-05-b



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 <u>Http://www.chinatl.com</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

| f [MHz] ^C | Relative Permittivity ^F | Conductivity (S/m) ^F | ConvF X | ConvF Y | ConvF Z | Alpha ^G | Depth ^G (mm) | Unct. (k=2) |
|----------------------|---------------------------------------|------------------------------------|---------|---------|---------|--------------------|----------------------------|----------------|
| 750 | 41.9 | 0.89 | 9.82 | 9.82 | 9.82 | 0.30 | 0.85 | ±12.1% |
| 835 | 41.5 | 0.90 | 9.71 | 9.71 | 9.71 | 0.15 | 1.36 | ±12.1% |
| 900 | 41.5 | 0.97 | 9,87 | 9.87 | 9.87 | 0.16 | 1.37 | +12.1% |
| 1750 | 40,1 | 1.37 | 8.61 | B.61 | 8.61 | 0.25 | 1.04 | 1 12.1% |
| 1900 | 40.0 | 1.40 | 8.13 | 8.13 | 8.13 | 0.24 | 1.01 | ±12.1% |
| 2100 | 39.8 | 1.49 | 8.14 | 8.14 | 8.14 | 0.24 | 1.04 | ±12.1% |
| 2300 | 39.5 | 1.67 | 7.85 | 7.85 | 7.85 | 0.40 | 0.75 | ±12.1% |
| 2450 | 39.2 | 1.80 | 7.57 | 7.57 | 7.57 | 0.50 | 0.75 | ±12.1% |
| 2600 | 39.0 | 1.96 | 7.38 | 7.38 | 7.38 | 0.64 | 0.68 | ±12.1% |
| 5250 | 35.9 | 4.71 | 5.33 | 5.33 | 5.33 | 0.45 | 1.30 | ±13.3% |
| 5600 | 35.5 | 5.07 | 4.89 | 4.89 | 4.89 | 0.45 | 1.35 | ±13.3% |
| 5750 | 35.4 | 5.22 | 4.92 | 4.92 | 4.92 | 0.45 | 1.45 | ±13.3% |

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

⁷ At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

¹⁷ Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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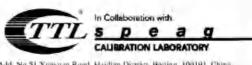
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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

| f [MHz] ^C | Relative Permittivity ^F | Conductivity (S/m) ^F | ConvF X | ConvF Y | ConvF Z | Alpha ^g | Depth ^G (mm) | Unct. (k=2) |
|----------------------|---------------------------------------|------------------------------------|---------|---------|---------|--------------------|----------------------------|----------------|
| 750 | 55.5 | 0.96 | 10.09 | 10.09 | 10.09 | 0.30 | 0.90 | ±12.1% |
| 835 | 55.2 | 0,97 | 9.88 | 9.88 | 9.88 | 0.19 | 1.32 | ±12.1% |
| 900 | 55.0 | 1.05 | 9.82 | 9.82 | 9.82 | 0.23 | 1.15 | ±12.1% |
| 1750 | 53.4 | 1.49 | 8.24 | 8.24 | 8.24 | 0.24 | 1.06 | ±12.1% |
| 1900 | 53.3 | 1.52 | 7.97 | 7.97 | 7.97 | 0.19 | 1.24 | ±12.1% |
| 2100 | 53.2 | 1,62 | 8.18 | 8.18 | 8 18 | 0.19 | 1.39 | ±12.1% |
| 2300 | 52.9 | 1.81 | 7.88 | 7.88 | 7.88 | 0.55 | 0.80 | +12.1% |
| 2450 | 52.7 | 1.95 | 7.53 | 7.53 | 7.53 | 0.46 | 0.89 | ±12.1% |
| 2600 | 52.5 | 2.16 | 7.38 | 7.38 | 7.38 | 0.52 | 0.80 | ±12.1% |
| 5250 | 48,9 | 5.36 | 4.93 | 4,93 | 4.93 | 0.45 | 1.80 | ±13.3% |
| 5600 | 48.5 | 5.77 | 4.19 | 4,19 | 4.19 | 0.48 | 1.90 | ±13.3% |
| 5750 | 48.3 | 5.94 | 4.52 | 4.52 | 4.52 | 0.48 | 1.95 | +13.3% |

¹⁰ Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^a Alpha/Depth are determined during calibration SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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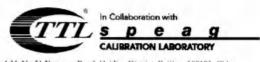
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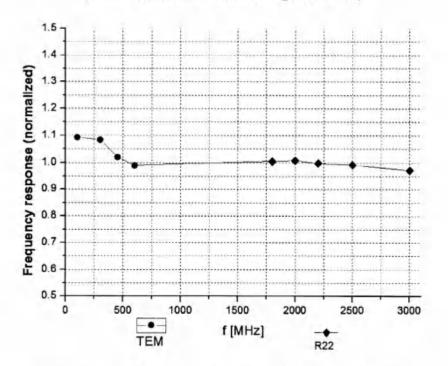


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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)





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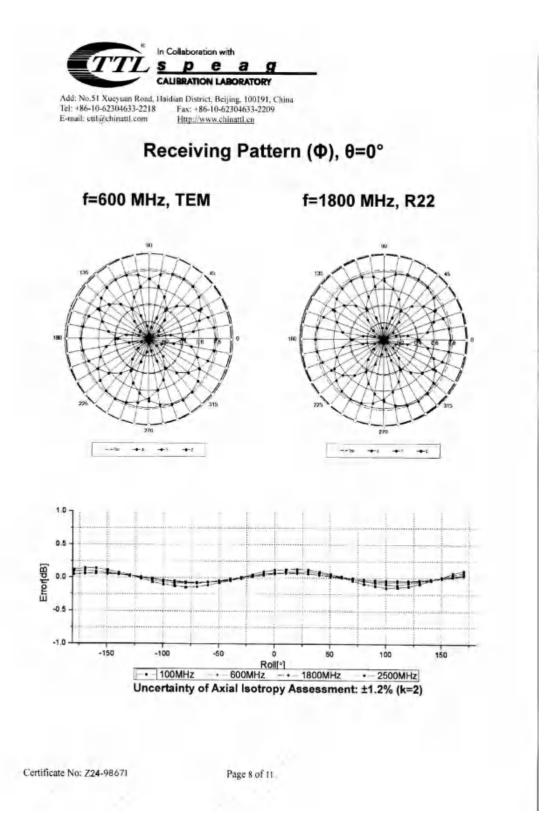
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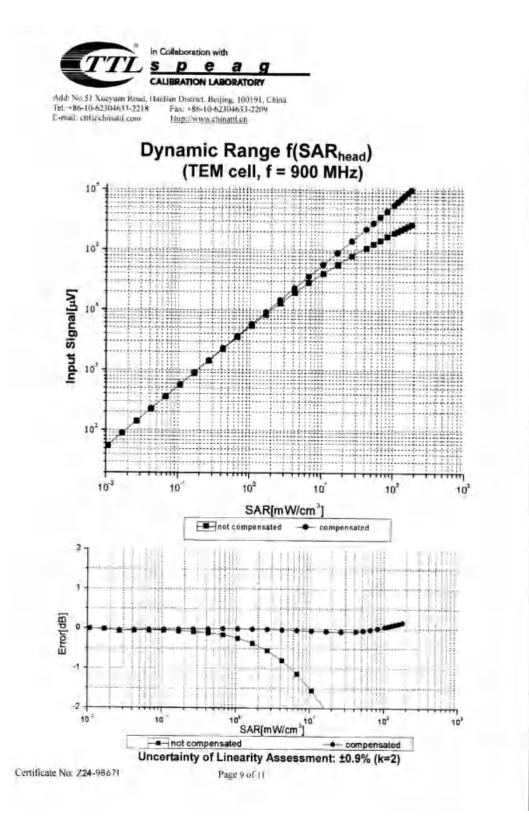
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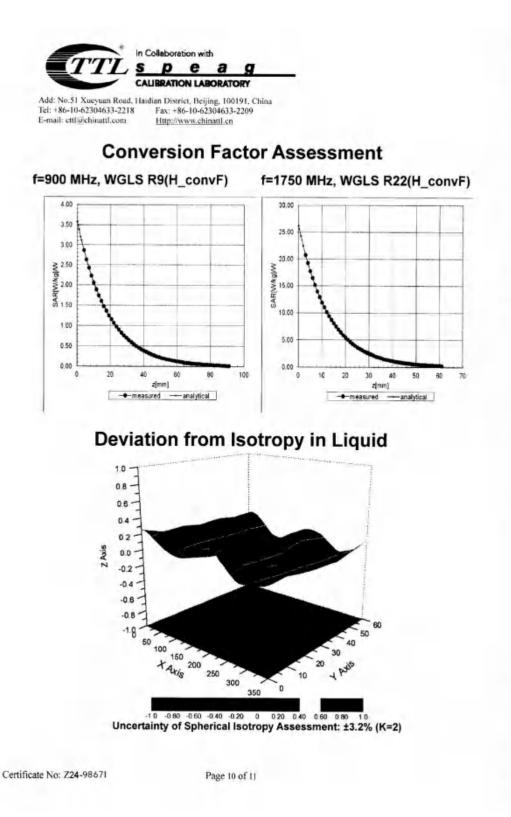
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Product Safety



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DASY/EASY - Parameters of Probe: EX3DV4 - SN: 7396

Other Probe Parameters

| Sensor Arrangement | Triangular |
|---|------------|
| Connector Angle (°) | 156.9 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disable |
| Probe Overall Length | 337mm |
| Probe Body Diameter | 10mm |
| Tip Length | 9mm |
| Tip Diameter | 2.5mm |
| Probe Tip to Sensor X Calibration Point | 1mm |
| Probe Tip to Sensor Y Calibration Point | 1mm |
| Probe Tip to Sensor Z Calibration Point | 1mm |
| Recommended Measurement Distance from Surface | 1.4mm |

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| Tel: -86-10-623046 L-mail: cttl@chinatt | | Resource officer | |
|---|--|--|--|
| Client Anboto | ok (Auden) | Certificate No: 22 | 4-97091 |
| CALIBRATION CE | RTIFICAT | E | |
| Object | D2450\ | /2 - SN: 910 | |
| Calibration Procedure(s) | FD-Z24 | -2-003-01 | |
| | Calibrat | tion Procedures for dipole validation kits | |
| Calibration date: | Jun 11, | 2024 | |
| pages and are part of the ce | artificate. | | |
| pages and are part of the ce -Feb All calibrations have been humidity<70% Calibration Equipment used | conducted in t | the closed laboratory facility environment or calibration) | temperature(22±3)℃ an |
| All calibrations have been humidity<70% | conducted in t | | temperature(22±3)℃ an Scheduled Calibration |
| Feb All calibrations have been humidity<70% Calibration Equipment used | conducted in t | or calibration) | |
| All calibrations have been humidity<70% Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 | Conducted in 1 (M&TE critical for ID# 101919 101547 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) | Scheduled Calibration |
| Feb All calibrations have been humidity<70% Calibration Equipment used Primary Standards Power Meter NRP2 | Conducted in 1 (M&TE critical for ID# 101919 101547 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) | Scheduled Calibration |
| All calibrations have been humidity<70% Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 | Conducted in 1 (M&TE critical for ID# 101919 101547 SN 7307 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24(SPEAG,No.EX3-7307_Feb24) | Scheduled Calibration Jul-24 Jul-24 Feb-25 |
| All calibrations have been humidity<70% Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 DAE4 | Conducted in 1 (M&TE critical fo 101919 101547 SN 7307 SN 771 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24(SPEAG,No.EX3-7307_Feb24) 02-Feb-24(CTTL-SPEAG,No.Z24-97011) | Scheduled Calibration Jul-24 Jul-24 Feb-25 Feb-25 |
| All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 DAE4 Secondary Standards | (M&TE critical fo ID# 101919 101547 SN 7307 SN 771 ID# MY49071430 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24 (SPEAG,No.EX3-7307_Feb24) 02-Feb-24 (CTTL-SPEAG,No.Z24-97011) Cal Date(Calibrated by, Certificate No.) | Scheduled Calibration Jul-24 Jul-24 Feb-25 Feb-25 Scheduled Calibration |
| All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C | (M&TE critical fo ID# 101919 101547 SN 7307 SN 771 ID# MY49071430 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24 (CTTL, No.J23X04256) 19-Feb-24 (CTTL-SPEAG,No.Z24-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-24 (CTTL_No.J24X00893) | Scheduled Calibration Jul-24 Jul-24 Feb-25 Feb-25 Scheduled Calibration Feb-25 |
| All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C Network Analyzer E5071C | Conducted in 1 (M&TE critical for 101919 101547 SN 7307 SN 771 ID # MY49071430 MY46110673 | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24(SPEAG,No.EX3-7307_Feb24) 02-Feb-24(CTTL-SPEAG,No.224-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-24 (CTTL_No.J24X00893) 26-Jan-24 (CTTL, No.J24X00894) | Scheduled Calibration Jul-24 Jul-24 Feb-25 Feb-25 Scheduled Calibration Feb-25 Jan-25 |
| All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C | Conducted in 1 (M&TE critical fo 101918 101547 SN 7307 SN 771 ID # MY49071430 MY46110673 Name | Cal Date(Calibrated by, Certificate No.) 01-Jul-23 (CTTL, No.J23X04256) 01-Jul-23 (CTTL, No.J23X04256) 19-Feb-24(SPEAG,No.EX3-7307_Feb24) 02-Feb-24(CTTL-SPEAG,No.Z24-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-24 (CTTL, No.J24X00893) 26-Jan-24 (CTTL, No.J24X00894) Function | Scheduled Calibration Jul-24 Jul-24 Feb-25 Feb-25 Scheduled Calibration Feb-25 Jan-25 |

Certificate No: Z24-97091

Page 1 of 8

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Tel =86-10-62104613-2079 E-mail: cttl/w.chimmil.com

Add: No.51 Xueyum Road, Haldian Diatrict, Benjing, 100191, China Fax: +86+10-62304633-2501 Hup. /www.chinarti.en

Glossary:

| TSL | tissue simulating liquid |
|-------|--------------------------------|
| ConvF | sensitivity in TSL / NORMx,y,z |
| N/A | not applicable or not measured |

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)". February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010
- d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

Certificate No: 224-97091

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Code:AB-RF-05-b



400-003-0500 www.anbotek.com







E-mail ctil@chinatil.com

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 Http://www.chinattl.on

Measurement Conditions

DASY system configuration, as far as not given on page 1

| DASY Version | DASY52 | 52.8.8.1258 |
|------------------------------|--------------------------|-------------|
| Extrapolation | Advanced Extrapolation | |
| Phantom | Triple Flat Phantom 5.1C | |
| Distance Dipole Center - TSL | 10 mm | with Spacer |
| Zoom Scan Resolution | dx, dy, dz = 5 mm | |
| Frequency | 2450 MHz ± 1 MHz | |

Head TSL parameters

The following parameters and calculations were applied

| | Temperature | Permittivity | Conductivity |
|---|-----------------------------|--------------|------------------|
| Nominal Head TSL parameters | 22.0 °C | 39.2 | 1.80 mho/m |
| Measured Head TSL parameters | (22.0 ± 0.2) ⁴ C | 39.0 ± 6 % | 1.77 mho/m ± 6 % |
| Head TSL temperature change during test | <1.0 °C | چين | |

SAR result with Head TSL

| SAR averaged over 1. cm ² (1 g) of Head TSL | Condition | |
|---|--------------------|---------------------------|
| SAR measured | 250 mW input power | 13.0 mW / g |
| SAR for nominal Head TSL parameters | normalized to 1W | 52.4 mW /g ± 20.8 % (k=2) |
| SAR averaged over 10 cm ³ (10 g) of Head TSL | Condition | |
| SAR measured | 250 mW input power | 6.06 mW / g |
| SAR for nominal Head TSL parameters | normalized to 1W | 24.3 mW /g ± 20.4 % (k=2) |

Body TSL parameters

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 52.7 | 1.95 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 52.9 ± 6 % | 1.97 mho/m ± 6 % |
| Body TSL temperature change during test | <1.0 °C | | |

SAR result with Body TSL

| SAR averaged over 1 cm ³ (1 g) of Body TSL | Condition | |
|---|--------------------|--|
| SAR measured | 250 mW input power | 13.0 mW/g |
| SAR for nominal Body TSL parameters | normalized to 1W | 51.8 mW /g ± 20.8 % (k=2) |
| SAR averaged over 10 cm ³ (10 g) of Body TSL | Condition | 1. |
| SAR measured | 250 mW input power | 6.18 mW/g |
| SAR for nominal Body TSL parameters | normalized to 1W | 24.7 mW /g ± 20.4 % (k=2) |

Certificate No: 7.24-97091

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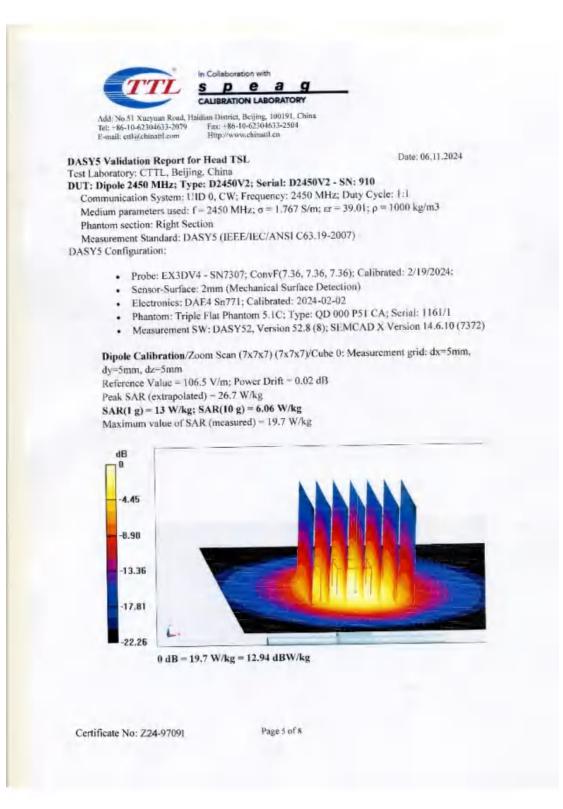
| [| Return Loss | |
|------------|--|---------------------------------|
| | | - 25.8dB |
| An | tenna Parameters with Body TSL | |
| T | Impedance, transformed to feed point | 50.7Ω+ 4.28jΩ |
| | Return Loss | - 27.3dB |
| Ge | eneral Antenna Parameters and Design | |
| 1 | Electrical Delay (one direction) | 1.263 ns |
| affe No | cording to the position as explained in the "Measur- ected by this change. The overall dipole length is s excessive force must be applied to the dipole arm nections near the feedpoint may be damaged. | till according to the Standard. |
| Ac | ditional EUT Data | |

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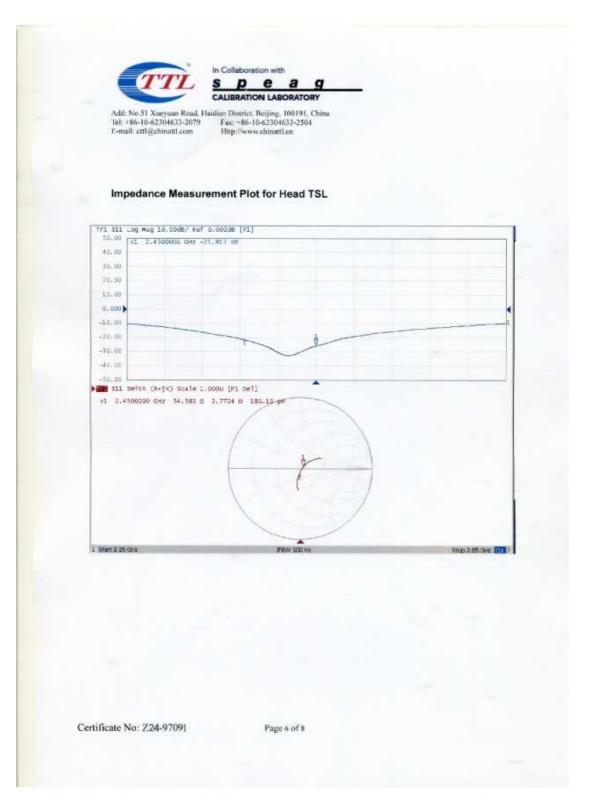
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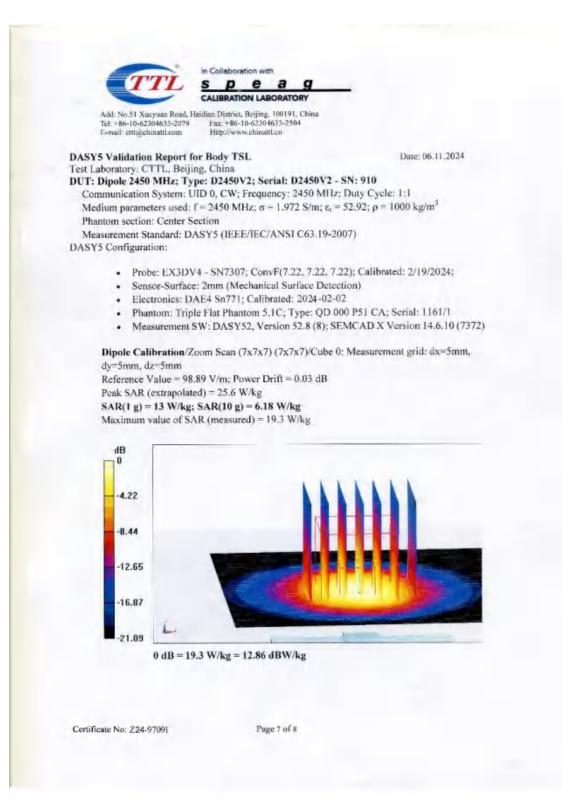


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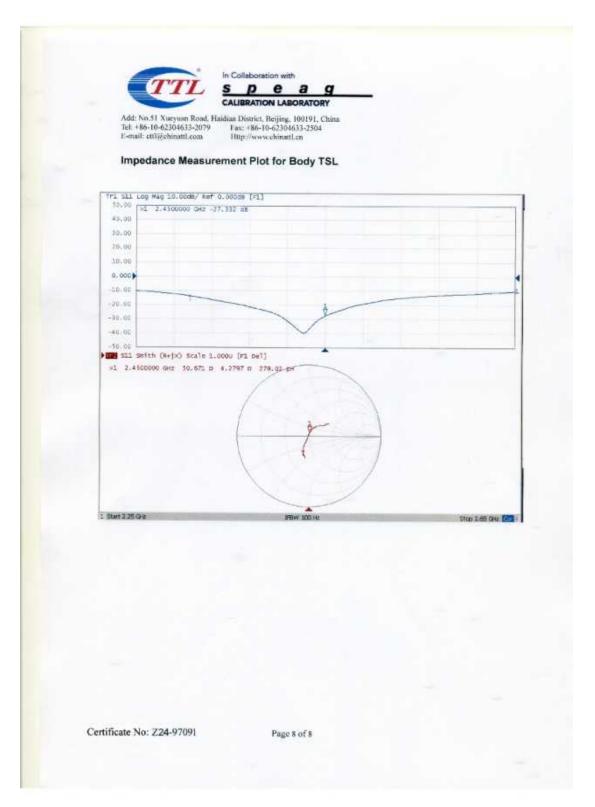
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| Engineering AG ughausstrasse 43, 8004 Zurich | , Switzerland | | S Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizie svizzern di taratura S Swiss Calibration Service |
|---|---|---|---|
| credited by the Swiss Accreditat e Swiss Accreditation Service ultilateral Agreement for the re | is one of the signatories | | Accreditation No.: SCS 0108 |
| ient Anbotek (Auden) | | | te No: D5GHzV2-1160_Oct11 |
| ALIBRATION C | ERTIFICATE | | |
| Abject | D5GHzV2 - SN: 1 | 160 | |
| talileration procedure(s) | QA CAL-22.v2 Calibration proces | dure for dipole validation kits | between 3-6 GHz |
| Calibration date: | October 02,2024 | | |
| The measurements and the unon All calibrations have been condu | rtainties with confidence pr cted in the closed laborator | onal standards, which realize the physic obability are given on the following pag y facility, environment temperature (22) | es and are part of the certificate. |
| The measurements and the unce Al calibrations have been conduct Calibration Equipment used (M& | ntainties with confidence protection of the closed laborator TE critical for calibration) | obability are given on the following pag y facility, environment temperature (22 | pes and are part of the certificate. |
| The measurements and the unon Al calibrations have been condui Calibration Equipment used (M& Primary Standards | ntainties with confidence protection of the closed laborator (Confidence) (Confiden | obability are given on the following pag y facility, environment temperature (22 Cal Date (Certificate No.) | pes and ané part of the certificate (a.3) C and humkSty < 70% Scheduled Calibration |
| The measurements and the unon Al calibrations have been condui Calibration Equipment used (M& Primary Standards Power meter FPM-442A | rtainties with confidence protect in the closed laboration FE critical for calibration) ID 3 GB37480704 | obability are given on the following pag y facility, environment temperature (22 Cal Date (Centricate No.) 07-Oct-23 (No. 217-02020) | es and are part of the certificate a.3) C and humidity < 70% Scheduled Calibration Oct 24 |
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| The measurements and the unce Micalibrations have been conduit Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sansor HP 8481A Power sansor HP 8481A Reference 20 48 Attonuator | Itaintics with confidence protect in the closed laborator TE critical for calibration) ID 3 GB37480704 US37292783 MY41092317 | Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) | es and ané part of the certificate a. 3) C and humidity < 70% Scheduled Galibration Oct 24 Oct-24 Oct-24 |
| The measurements and the unce Al calibrations have been conduit Calibration Equipment used (M& Primary Standards Power meter CPM 442A Priver sansor HP 8481A Power sensor HP 8481A Reference 20 48 Attanuator Type-N mismatch combination Patemence Probe EXSDV4 | ntainties with confidence protection of the closed laborator (Confidence) (Confiden | Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02120) 07-Oct-23 (No. 217-02121) 01-Apr.24 (No. 217-02121) 01-Apr.24 (No. 217-02124) 30-Dec.23 (No. FX3-3503 Dec.14) | es and are part of the certificate a. 3) C and humidity < 70% Scheduled Calibration Oct 24 Oct-24 Oct-24 Oct-25 Apr-25 Dec-24 |
| The measurements and the unce Al calibrations have been conduit Calibration Equipment used (M& Primary Standards Power meter CPM 442A Priver sansor HP 8481A Power sensor HP 8481A Reference 20 48 Attanuator Type-N mismatch combination Patemence Probe EXSDV4 | rtainties with confidence protection of the closed laborator (Confidence) (Confiden | cbability are given on the following pag y facility, environment temperature (22 Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02021) 01-Apt-24 (No. 217-02124) | es and are part of the certificate a. 3) C and humidity < 70% Scheduled Calibration Oct 24 Oct-24 Oct-24 Oct-25 Apr-25 Apr-25 |
| The measurements and the unce Al calibrations have been conduct Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 20 498 Attanuator Type-N mismatch combination Patternote Probe EXSDV4 DAE4 24 | Itainties with confidence provided in the closed laboration) IC al IC | Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02131) 01-Apr-24 (No. 217-02131) 01-Apr-24 (No. 217-02131) 01-Apr-24 (No. 217-02131) 01-Apr-24 (No. DAE4-601 Aug15) | es and are part of the certificate a. 3) C and humidity < 70% Scheduled Calibration Oct 24 Oct-24 Oct-24 Oct-25 Apr-25 Dec-24 |
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| The measurements and the unce All calibrations have been conduct Galibration Equipment used (M& Primary Standards Power neter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 20 dB Attonuator Type-N mismatch combinetion Reference Probe EXSDV4 DAE4 24 Secondary Standards RF generator R&S SMT-06 | Intainties with confidence provided in the closed laboration) E critical for calibration) ID 3 GB37480704 US37292783 MY41092317 SN: 5068 (20k) SN: 5068 (20k) SN: 5068 (20k) SN: 5067 2 / 06327 SN: 3503 SN: 601 ID # | coability are given on the following pag glacility, environment temperature (22 Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02121) 01-Apr-24 (No. 217-02124) 10-Apr-24 (No. 217-02124) 10-Apr-24 (No. 217-02124) 10-Apr-24 (No. 217-02124) 10-Apr-24 (No. DAE4-601 Aug15) Check Date (n house) | es and ere part of the certificate a. 3) C and humidity < 70% Scheduled Galibration Oct 24 Oct-24 Oct-24 Oct-24 Apr-25 Apr-25 Dec-24 Aug-25 Scheduled Check |
| The measurements and the unce Al calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combinistion Reference Probe EXSDV4 | rtainties with confidence pr ted in the closed laboration) ID J 0B37480704 US37292783 MY41092317 SN: 5058 (20)6327 SN: 5047 2 06327 SN: 5047 2 06327 SN: 601 ID # 100972 US37390585 S4206 Name | Cal Date (Certificate No.) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02131) 01-Apr-24 (No. 217-02121) 01-Apr-24 (No. 217-02124) 30-Dec (23 (No. FX3-3503, Dec14) 17-Aug-24 (No. DAE4-601, Aug15) Check Date (in house) 18-Jun-24 (in bauen check Jun-15) 15-Oct-23 (in house check Oct-14) | es and ere part of the certificate a. 3) C and humidity < 70% Scheduled Calibration Oct 24 Oct-24 Oct-24 Apr-25 Apr-25 Dec-24 Aug-25 Scheduled Chieck In house check: Jun-27 |
| The measurements and the ance Al calibrations have been conduct Calibration Equipment used (M&C Primary Standards Power sensor HP 8481A Power sensor HP 8481A Secondary Standards RE generator R&S SMT-06 Network Analyzer HP 8753E | rtainties with confidence products with confidence products of the closed laboration (Confidence) (Confidence | cbability are given on the following pag y facility, environment temperature (22 Cal Date (Certriteate No.) D7-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02020) 07-Oct-23 (No. 217-02131) 01-Apr 24 (No. 217-02131) 01-Apr 24 (No. 217-02124) 30-Dec-23 (No. FX3-3503, Dec14) 17-Aug-24 (No. DAE4-601, Aug15) Check Date (In house) 16-Jon-24 (In house check Jun-15) 15-Oct-23 (In house check Oct-14) | es and ere part of the certificate a. 3) C and humidity < 70% Scheduled Galibration Oct 24 Oct-24 Oct-24 Oct-24 Apr-25 Apr-25 Dec-24 Aug-25 Scheduled Check In house check: Jun-27 In house check: Oct-24 Signature |
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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di tanature Swiss Calibration Service

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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS). The Swins Accreditation Service is one of the signatones to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

| TSL | tissue simulating liquid |
|-------|---------------------------------|
| ConvF | sensitivity in TSL / NORM x,y,z |
| N/A. | not applicable or not measured |

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques". June 2013
- b) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless." communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010.
- c) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

d) DASY4/5 System Handbook.

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%

Centricate No: 05GHzV2-1160_06/11 Page 2 of 15

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

| DASY Version | DASY5 | V52.8.8 |
|------------------------------|--|---------------------------------|
| Extrapolation | Advanced Extrapolation | |
| Phantom | Modular Flat Phantom V5.0 | |
| Distance Dipole Center - TSL | 10 mm | with Spacer |
| Zoom Scan Resolution | dx, dy = 4.0 mm, dz = 1.4 mm | Graded Ratio = 1.4 (Z direction |
| Frequency | 5200 MHz ± 1 MHz 5300 MHz ± 1 MHz 5600 MHz ± 1 MHz 5800 MHz ± 1 MHz | |

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Head TSL parameters | 22.0 °C | 36.0 | 4.66 mho/m |
| Measured Head TSL parameters | (22.0 ± 0.2) "C | 36.4 ± 6 % | 4.57 mho/m ± 6 % |
| Head TSL temperature change during test | < 0.5 °C | | (size) |

SAR result with Head TSL at 5200 MHz

| SAR averaged over 1 cm ³ (1 g) of Head TSL | Condition | |
|---|---------------------------------|--------------------------|
| SAR measured | 100 mW input power | 8.06 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | 80.7 W/kg ± 19.9 % (k=2) |
| | | |
| SAR averaged over 10 cm ³ (10 g) of Head TSL | condition | |
| SAR averaged over 10 cm ³ (10 g) of Head TSL SAR measured | condition 100 mW input power | 2.31 W/kg |

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Head TSL parameters at 5300 MHz

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Head TSL parameters | 22.0 °C | 35.9 | 4.76 mho/m |
| Measured Head TSL parameters | (22.0 ± 0.2) "C | 36.2 ± 6 % | 4.68 mho/m ± 5 % |
| Head TSL temperature change during test | < 0.5 °C | - 14 | at the second |

SAR result with Head TSL at 5300 MHz

| SAR averaged over 1 cm ³ (1 g) of Head TSL | Condition | |
|---|---------------------------------|----------------------------|
| SAR measured | 100 mW input power | 8.26 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | 82.7 W / kg ± 19.9 % (k=2) |
| | | |
| SAR averaged over 10 cm ² (10 g) of Head TSL | condition | |
| SAR averaged over 10 cm ³ (10 g) of Head TSL SAR measured | candition 100 mW input power | 2.39 W/kg |

Head TSL parameters at 5600 MHz

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Head TSL parameters | 22.0 °C | 35.5 | 5.07 mho/m |
| Measured Head TSL parameters | (22.0 ± 0.2) °C | 35.7 ± 6 % | 5.03 mhd/m ± 6 % |
| Head TSL temperature change during test | < 0.5 °C | | |

SAR result with Head TSL at 5600 MHz

| SAR averaged over 1 cm3 (1 g) of Head TSL | Condition | |
|---|--------------------|---------------------------|
| SAR measured | 100 mW input power | 8.69 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | .87.0 W/kg ± 19.9 % (k=2) |
| SAR averaged over 10 cm ³ (10 g) of Head TSL | condition | |

| SAH averaged over 10 cm (10 g) of Head TSL | condition | |
|--|--------------------|--------------------------|
| SAR measured | 100 mW input power | 2.47 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | 24.7 W/kg ± 19.5 % (k=2) |

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Head TSL parameters at 5800 MHz

| The following | parameters. | and calculations | were applied | |
|--|--|------------------|---------------------------------|---|
| provide the second seco | a Contractor of the second second second | | Contractor of the second second | _ |

| | Temperature | Permittivity | Conductivity |
|---|-----------------|---------------|------------------|
| Nominal Head TSL parameters | 22.0 °C | 35.3 | 5.27 mho/m |
| Measured Head TSL parameters | (22.0 ± 0.2) °C | $35.3\pm6~\%$ | 5.26 mho/m ± 6 % |
| Head TSL temperature change during test | < 0.5 °C | (=) | |

SAR result with Head TSL at 5800 MHz

| SAR averaged over 1 cm ³ (1 g) of Head TSL | Condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 8.20 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | 82.0 W/kg ± 19.9 % (k=2) |

| SAR averaged over 10 cm ³ (10 g) of Head TSL | condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 2.31 W/kg |
| SAR for nominal Head TSL parameters | normalized to 1W | 23.1 W/kg ± 19.5 % (k=2) |

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Code:AB-RF-05-b



d



Body TSL parameters at 5200 MHz

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 49.0 | 5.30 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 47.9+6% | 5.35 mho/m ± 6 % |
| Body TSL temperature change during test | < 0.5 °C | 2000 C | |

SAR result with Body TSL at 5200 MHz

| SAR averaged over 1 cm ³ (1 g) of Body TSL | Condition | |
|---|---------------------------------|--------------------------|
| SAR measured | 100 mW input power | 7.81 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 77.8 W/kg ± 19.9 % (k=2) |
| | | |
| SAB averaged over 10 cm3 (10 g) of Body TSL | condition | |
| SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured | condition 100 mW input power | 2.18 W/kg |

Body TSL parameters at 5300 MHz

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 48.9 | 5.42 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 47.7±6% | 5.49 mho/m ± 6 % |
| Body TSL temperature change during test | < 0.5 °C | | - |

SAR result with Body TSL at 5300 MHz

| SAR averaged over 1 cm3 (1 g) of Body TSL | Condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 7.88 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 78.4 W/kg ± 19.9 % (k=2) |

| SAR averaged over 10 cm3 (10 g) of Body TSL | condition | |
|---|--------------------|--------------------------|
| SAFI measured | 100 mW input power | 2.20 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 21.9 W/kg ± 19.5 % (k=2) |

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Body TSL parameters at 5600 MHz

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 48.5 | 5.77 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 46.7 ± 6 % | 5.99 mho/m ± 6 % |
| Body TSL temperature change during test | < 0.5 °C | | |

SAR result with Body TSL at 5600 MHz

| SAR averaged over 1 cm ³ (1 g) of Body TSL | Condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 8.20 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 81.5 W/kg ± 19.9 % (k=2) |

| SAR averaged over 10 cm ² (10 g) of Body TSL | condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 2,30 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 22.8 W/kg ± 19.5 % (k=2) |

Body TSL parameters at 5800 MHz

The following parameters and calculations were applied

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 48.2 | 6,00 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 46.4 ± 6 % | 6.27 mho/m ± 6 % |
| Body TSL temperature change during test | < 0.5 °C | | |

SAR result with Body TSL at 5800 MHz

| SAR averaged over 1 cm3 (1 g) of Body TSL | Condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 7.88 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 78.3 W/kg ± 19.9 % (k=2) |

| SAR averaged over 10 cm3 (10 g) of Body TSL | condition | |
|---|--------------------|--------------------------|
| SAR measured | 100 mW input power | 2.20 W/kg |
| SAR for nominal Body TSL parameters | normalized to 1W | 21.8 W/kg ± 19.5 % (k=2) |

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with Head TSL at 5200 MHz

| Impedance, transformed to feed point | 48.1 12 - 8.5 jΩ |
|--------------------------------------|------------------|
| Return Loss | - 21.0 dB |

Antenna Parameters with Head TSL at 5300 MHz

| Impedance, transformed to feed point | -50.2.13 - 5.2 jΩ |
|--------------------------------------|-------------------|
| Return Loss | - 25.7 dB |

Antenna Parameters with Head TSL at 5600 MHz

| Impedance, transformed to feed point | 54,8 Q - 2,5 JQ |
|--------------------------------------|-----------------|
| Return Loss | - 25.7 dB |

Antenna Parameters with Head TSL at 5800 MHz

| Impedance, transformed to feed point | 53.0 Ω - 3.0 jΩ |
|--------------------------------------|-----------------|
| Return Loss | >27.7 dB |

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Antenna Parameters with Body TSL at 5200 MHz

| Impedance, transformed to feed point | 48,6 <u>12</u> - 6,8 <u>J</u> <u></u> <u></u> <u></u> <u></u> 2 |
|--------------------------------------|---|
| Return Loss | - 23.0 dB |

Antenna Parameters with Body TSL at 5300 MHz

| Impedance, transformed to feed point | 49.0 Ω - 4.2 JΩ |
|--------------------------------------|-----------------|
| Return Loss. | -27.1 dB |

Antenna Parameters with Body TSL at 5600 MHz

| Investigance, transformed to land point | 56.2 Q = 0.7 KQ |
|---|-----------------|
| Impedance, transformed to feed point | |
| Return Loss | - 24.6 dB |

Antenna Parameters with Body TSL at 5800 MHz

| Impedance, transformed to feed point | 55.9 Ω - 1.7 jΩ |
|--------------------------------------|-----------------|
| Return Loss | - 24.8 dB |

General Antenna Parameters and Design

| Electrical Delay (one direction) | 1.199 ns |
|----------------------------------|----------|
| Enconical Bone) (one another) | |

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

| Manufactured by | SPEAG |
|-----------------|---------------|
| Manufactured on | June 06, 2013 |

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DASY5 Validation Report for Head TSL

Date: 24.09/2024

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 - CW; Prequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5600 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; $\sigma = 4.57$ S/m; $c_t = 36.4$; $\rho = 1000$ kg/m³. Medium parameters used: f = 5300 MHz; $\sigma = 4.68$ S/m; $c_t = 36.2$; $\rho = 1000$ kg/m³. Medium parameters used: f = 5600 MHz; $\sigma = 5.03$ S/m; $c_t = 35.7$; $\rho = 1000$ kg/m³. Medium parameters used: f = 5800 MHz; $\sigma = 5.26$ S/m; $c_t = 35.3$; $\rho = 1000$ kg/m³.

Phanlom section: Flat Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(5.51, 5.51, 5.51); Calibrated: 10.09.2024; ConvF(5.21, 5.21); 5.21); Calibrated: 10.09.2024; ConvF(4.92, 4.92, 4.92); Calibrated: 10.09.2024; ConvF(4.9, 4.9, 4.9); Calibrated: 10.09.2024;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics DAE4 Sn601; Calibrated: 17.08,2024
- Phantom: Flat Phantom 5.0 (front): Type: QD000P50AA; Serial: 1001
- DASY52 52 8.8(1222); SEMCAD X 14.6 (0(7331))

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Sean, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 64.41 V/m; Power Drift = 0.08 dB Peak SAR (extrapolated) = 29.3 W/kg SAR(1 g) = 8.06 W/kg; SAR(10 g) = 2.31 W/kg Maximum value of SAR (measured) = 18.7 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.31 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 31.1 W/kg SAR(1 g) = 8.26 W/kg; SAR(10 g) = 2.39 W/kg Maximum value of SAR (measured) = 19.4 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.34 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 34.7 W/kg SAR(1 g) = 8.69 W/kg; SAR(10 g) = 2.47 W/kg Maximum value of SAR (measured) = 21.0 W/kg

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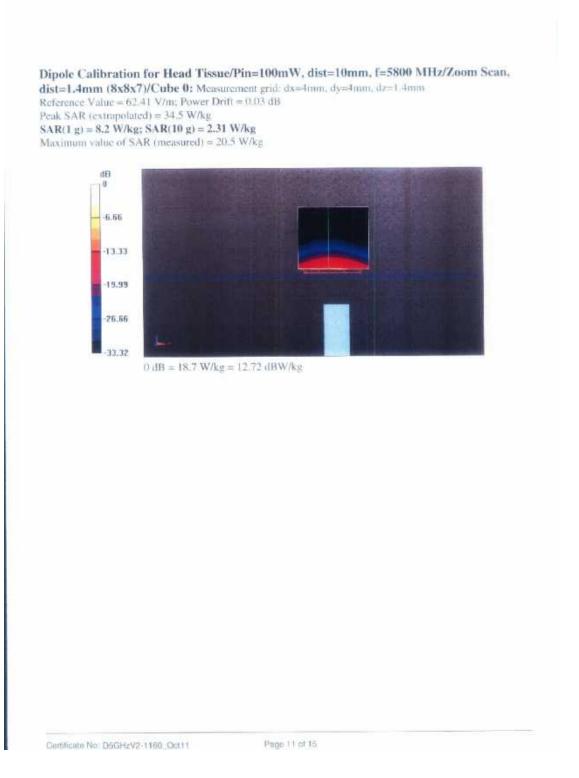
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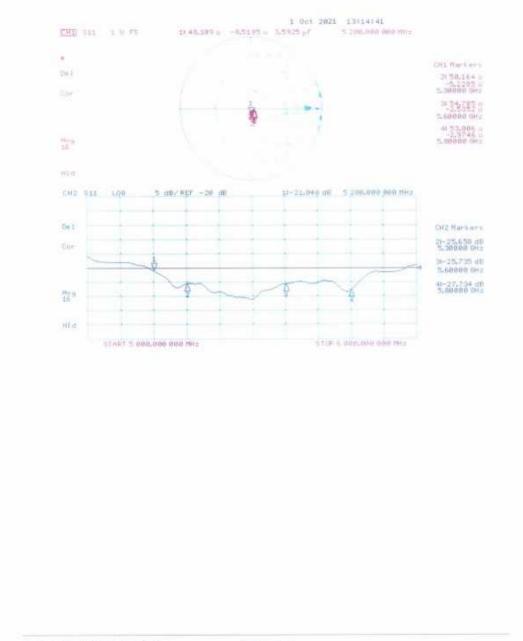
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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date: 05 10 2024

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 CW: Frequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5800 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; σ = 5.35 S/m; ϵ_r = 47.9; ρ = 1000 kg/m³. Medium parameters used: f = 5600 MHz; σ = 5.49 S/m; ϵ_r = 47.7; ρ = 1000 kg/m³. Medium parameters used: f = 5600 MHz; σ = 5.99 S/m; ϵ_r = 46.7; ρ = 1000 kg/m³. Medium parameters used: f = 5800 MHz; σ = 6.27 S/m; ϵ_r = 46.4; ρ = 1000 kg/m³.

Phantom section: Flat Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63,19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(4.95, 4.95, 4.95); Calibrated: 05.10.2024, ConvF(4.78, 4.78, 4.78); Calibrated: 05.10.2024; ConvF(4.35, 4.35, 4.35), Calibrated: 05.10.2024; ConvF(4.32, 4.32); Calibrated: 05.10.2024;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
 - Electronics: DAL4 Sn601; Calibrated: 17.08 2024
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Senal: 1002
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid; dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.32 V/m; Power Drift = -0.04 dB Peak SAR (extrapolated) = 30.4 W/kg SAR(1 g) = 7.81 W/kg; SAR(10 g) = 2.18 W/kg Maximum value of SAR (measured) = 18.2 W/kg

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1,4mm Reference Value = 67.22 V/m; Power Drift = -0.06 dB Peak SAR (extrapolated) = 31.6 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 18.8 W/kg

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.36 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 36.6 W/kg SAR(1 g) = 8.2 W/kg; SAR(10 g) = 2.3 W/kg Maximum value of SAR (measured) = 20.2 W/kg

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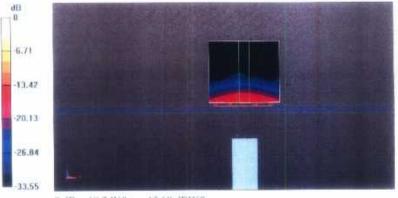
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Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.22 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 37.1 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 18.2 W/kg = 12.60 dBW/kg

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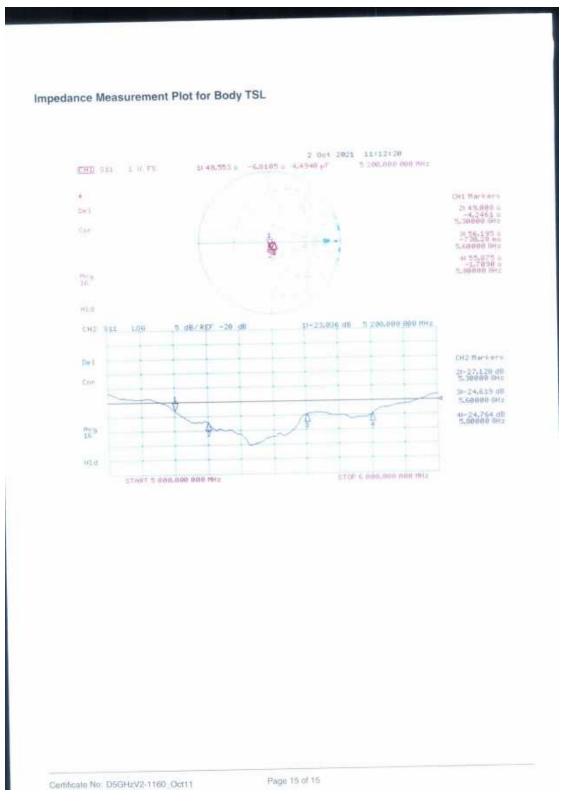
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